

MSP430FW42x Mixed-Signal Microcontroller

FEATURES

- Low Supply Voltage Range: 1.8 V to 3.6 V
- Ultra-Low-Power Consumption:
 - Active Mode: 200 μ A at 1 MHz, 2.2 V
 - Standby Mode: 0.7 μ A
 - Off Mode (RAM Retention): 0.1 μ A
- Five Power-Saving Modes
- Wake Up From Standby Mode in Less Than 6 μ s
- Frequency-Locked Loop, FLL+
- 16-Bit RISC Architecture, 125-ns Instruction Cycle Time
- Scan Interface for Background Water, Heat, and Gas Volume Measurement
- 16-Bit Timer_A With Three Capture/Compare Registers
- 16-Bit Timer_A With Five Capture/Compare Registers
- Integrated LCD Driver for Up to 96 Segments
- On-Chip Comparator
- Serial Onboard Programming, No External Programming Voltage Needed Programmable Code Protection by Security Fuse
- Brownout Detector
- Supply Voltage Supervisor and Monitor With Programmable Level Detection
- Bootstrap Loader (BSL) in Flash Devices
- Family Members Include:
 - MSP430FW423
8KB + 256B Flash Memory, 256B RAM
 - MSP430FW425
16KB + 256B Flash Memory, 512B RAM
 - MSP430FW427
32KB + 256B Flash Memory, 1KB RAM
 - MSP430FW428
48KB + 256B Flash Memory, 2KB RAM
 - MSP430FW429
60KB + 256B Flash Memory, 2KB RAM

- Available in 64-Pin Quad Flat Pack (QFP)
- For Complete Module Descriptions, See the *MSP430x4xx Family User's Guide*, Literature Number [SLAU056](#)

APPLICATIONS

- Analog Sensor Systems
- Digital Sensor Systems
- Gas, Heat, or Water Meters
- Industrial Meters
- Hand-Held Meters

DESCRIPTION

The Texas Instruments MSP430™ family of ultra-low-power microcontrollers consists of several devices featuring different sets of peripherals targeted for various applications. The architecture, combined with five low-power modes, is optimized to achieve extended battery life in portable measurement applications. The device features a powerful 16-bit RISC CPU, 16-bit registers, and constant generators that contribute to maximum code efficiency. The digitally controlled oscillator (DCO) allows the device to wake up from low-power modes to active mode in less than 6 μ s.

The MSP430FW42x series are microcontroller configurations with two built-in 16-bit timers, a comparator, 96 LCD segment drive capability, a scan interface, and 48 I/O pins.

Typical applications include sensor systems that capture analog signals, convert them to digital values, and process the data and transmit them to a host system. The comparator and timers make the configurations ideal for gas, heat, and water meters, industrial meters, counter applications, and hand-held meters.



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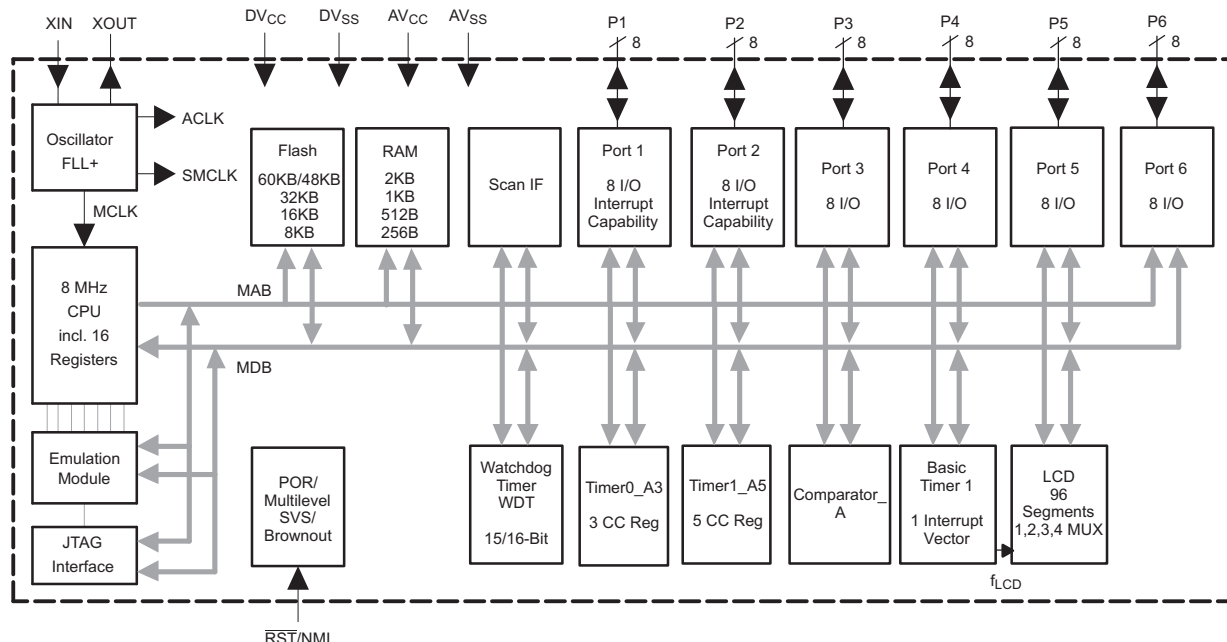
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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

Functional Block Diagram



Pin Designation

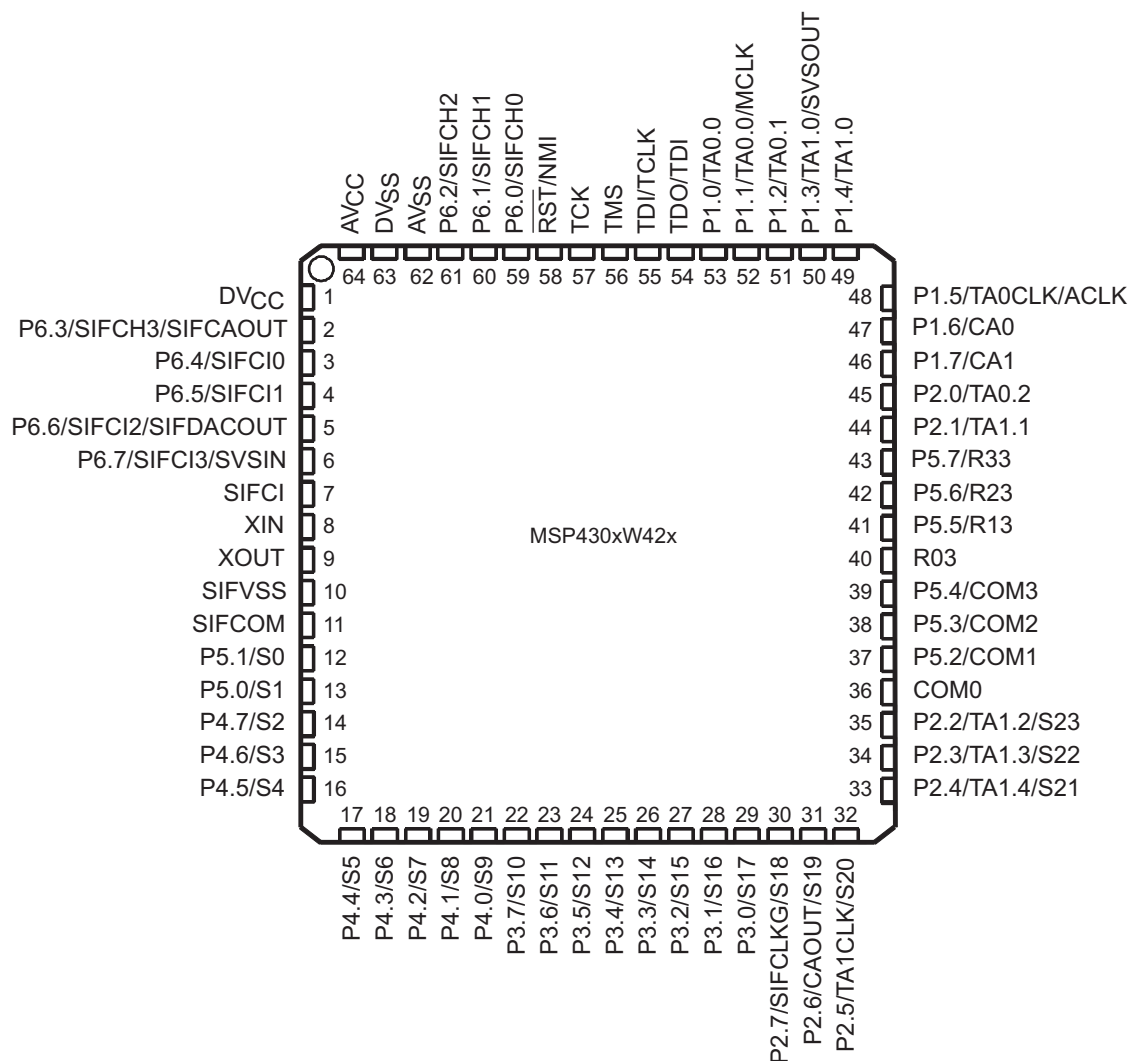


Table 1. Terminal Functions

| TERMINAL | | I/O | DESCRIPTION |
|-------------------|-----|-----|--|
| NAME | NO. | | |
| AV _{CC} | 64 | | Analog supply voltage, positive terminal. Supplies SVS, brownout, oscillator, comparator_A, scan IF AFE, port 6, and LCD resistive divider circuitry; must not power up prior to DV _{CC} . |
| AV _{SS} | 62 | | Analog supply voltage, negative terminal. Supplies SVS, brownout, oscillator, comparator_A, scan IF AFE, and port 6. Must be externally connected to DV _{SS} . Internally connected to DV _{SS} . |
| DV _{CC} | 1 | | Digital supply voltage, positive terminal. |
| DV _{SS} | 63 | | Digital supply voltage, negative terminal. |
| SIFVSS | 10 | | Scan IF AFE reference supply voltage. |
| P1.0/TA0.0 | 53 | I/O | General-purpose digital I/O Timer0_A. Capture: CCI0A input, compare: Out0 output BSL transmit |
| P1.1/TA0.0/MCLK | 52 | I/O | General-purpose digital I/O Timer0_A. Capture: CCI0B input MCLK output BSL receive Note: TA0.0 is only an input on this pin. |
| P1.2/TA0.1 | 51 | I/O | General-purpose digital I/O Timer0_A, capture: CCI1A input, compare: Out1 output |
| P1.3/TA1.0/SVSOUT | 50 | I/O | General-purpose digital I/O Timer1_A, capture: CCI0B input SVS: output of SVS comparator Note: TA1.0 is only an input on this pin. |
| P1.4/TA1.0 | 49 | I/O | General-purpose digital I/O Timer1_A, capture: CCI0A input, compare: Out0 output |
| P1.5/TA0CLK/ACLK | 48 | I/O | General-purpose digital I/O Input of Timer0_A clock Output of ACLK |
| P1.6/CA0 | 47 | I/O | General-purpose digital I/O Comparator_A input |
| P1.7/CA1 | 46 | I/O | General-purpose digital I/O Comparator_A input |
| P2.0/TA0.2 | 45 | I/O | General-purpose digital I/O Timer0_A, capture: CCI2A input, compare: Out2 output |
| P2.1/TA1.1 | 44 | I/O | General-purpose digital I/O Timer0_A, capture: CCI1A input, compare: Out1 output |
| P2.2/TA1.2/S23 | 35 | I/O | General-purpose digital I/O Timer1_A, capture: CCI2A input, compare: Out2 output LCD segment output 23 ⁽¹⁾ |
| P2.3/TA1.3/S22 | 34 | I/O | General-purpose digital I/O Timer1_A, capture: CCI3A input, compare: Out3 output LCD segment output 22 ⁽¹⁾ |
| P2.4/TA1.4/S21 | 33 | I/O | General-purpose digital I/O Timer1_A, capture: CCI4A input, compare: Out4 output LCD segment output 21 ⁽¹⁾ |
| P2.5/TA1CLK/S20 | 32 | I/O | General-purpose digital I/O Input of Timer1_A clock LCD segment output 20 ⁽¹⁾ |
| P2.6/CAOUT/S19 | 31 | I/O | General-purpose digital I/O Comparator_A output LCD segment output 19 ⁽¹⁾ |
| P2.7/SIFCLKG/S18 | 30 | I/O | General-purpose digital I/O Scan IF, signal SIFCLKG from internal clock generator LCD segment output 18 ⁽¹⁾ |
| P3.0/S17 | 29 | I/O | General-purpose digital I/O LCD segment output 17 ⁽¹⁾ |
| P3.1/S16 | 28 | I/O | General-purpose digital I/O LCD segment output 16 ⁽¹⁾ |

(1) LCD function selected automatically when applicable LCD module control bits are set, not with PxSEL bits.

Table 1. Terminal Functions (continued)

| TERMINAL | | I/O | DESCRIPTION |
|-------------|-----|-----|--|
| NAME | NO. | | |
| P3.2/S15 | 27 | I/O | General-purpose digital I/O LCD segment output 15 ⁽¹⁾ |
| P3.3/S14 | 26 | I/O | General-purpose digital I/O LCD segment output 14 ⁽¹⁾ |
| P3.4/S13 | 25 | I/O | General-purpose digital I/O LCD segment output 13 ⁽¹⁾ |
| P3.5/S12 | 24 | I/O | General-purpose digital I/O LCD segment output 12 ⁽¹⁾ |
| P3.6/S11 | 23 | I/O | General-purpose digital I/O LCD segment output 11 ⁽¹⁾ |
| P3.7/S10 | 22 | I/O | General-purpose digital I/O LCD segment output 10 ⁽¹⁾ |
| P4.0/S9 | 21 | I/O | General-purpose digital I/O LCD segment output 9 ⁽¹⁾ |
| P4.1/S8 | 20 | I/O | General-purpose digital I/O LCD segment output 8 ⁽²⁾ |
| P4.2/S7 | 19 | I/O | General-purpose digital I/O LCD segment output 7 ⁽²⁾ |
| P4.3/S6 | 18 | I/O | General-purpose digital I/O LCD segment output 6 ⁽²⁾ |
| P4.4/S5 | 17 | I/O | General-purpose digital I/O LCD segment output 5 ⁽²⁾ |
| P4.5/S4 | 16 | I/O | General-purpose digital I/O LCD segment output 4 ⁽²⁾ |
| P4.6/S3 | 15 | I/O | General-purpose digital I/O LCD segment output 3 ⁽²⁾ |
| P4.7/S2 | 14 | I/O | General-purpose digital I/O LCD segment output 2 ⁽²⁾ |
| P5.0/S1 | 13 | I/O | General-purpose digital I/O LCD segment output 1 ⁽²⁾ |
| P5.1/S0 | 12 | I/O | General-purpose digital I/O LCD segment output 0 ⁽²⁾ |
| COM0 | 36 | O | Common output. COM0-3 are used for LCD backplanes |
| P5.2/COM1 | 37 | I/O | General-purpose digital I/O Common output. COM0-3 are used for LCD backplanes |
| P5.3/COM2 | 38 | I/O | General-purpose digital I/O Common output. COM0-3 are used for LCD backplanes |
| P5.4/COM3 | 39 | I/O | General-purpose digital I/O Common output. COM0-3 are used for LCD backplanes |
| R03 | 40 | I | Input port of fourth positive (lowest) analog LCD level (V5) |
| P5.5/R13 | 41 | I/O | General-purpose digital I/O Input port of third most positive analog LCD level (V4 or V3) |
| P5.6/R23 | 42 | I/O | General-purpose digital I/O Input port of second most positive analog LCD level (V2) |
| P5.7/R33 | 43 | I/O | General-purpose digital I/O Output port of most positive analog LCD level (V1) |
| P6.0/SIFCH0 | 59 | I/O | General-purpose digital I/O Scan IF, channel 0 sensor excitation output and signal input |
| P6.1/SIFCH1 | 60 | I/O | General-purpose digital I/O Scan IF, channel 1 sensor excitation output and signal input |
| P6.2/SIFCH2 | 61 | I/O | General-purpose digital I/O Scan IF, channel 2 sensor excitation output and signal input |

(2) LCD function selected automatically when applicable LCD module control bits are set, not with PxSEL bits.

Table 1. Terminal Functions (continued)

| TERMINAL | | I/O | DESCRIPTION |
|---------------------------|-----|-----|--|
| NAME | NO. | | |
| P6.3/SIFCH3/ SIFCAOUT | 2 | I/O | General-purpose digital I/O Scan IF, channel 3 sensor excitation output and signal input Scan IF comparator output |
| P6.4/SIFCI0 | 3 | I/O | General-purpose digital I/O Scan IF, channel 0 signal input to comparator |
| P6.5/SIFCI1 | 4 | I/O | General-purpose digital I/O Scan IF, channel 1 signal input to comparator |
| P6.6/SIFCI2/ SIFDACOUT | 5 | I/O | General-purpose digital I/O Scan IF, channel 2 signal input to comparator 10-bit DAC output |
| P6.7/SIFCI3/SVSIN | 6 | I/O | General-purpose digital I/O Scan IF, channel 3 signal input to comparator SVS, analog input |
| SIFCI | 7 | I | Scan IF input to Comparator. |
| SIFCOM | 11 | O | Common termination for Scan IF sensors. |
| RST/NMI | 58 | I | Reset input or nonmaskable interrupt input port. |
| TCK | 57 | I | Test clock. TCK is the clock input port for device programming and test. |
| TDI/TCLK | 55 | I | Test data input or test clock input. The device protection fuse is connected to TDI/TCLK. |
| TDO/TDI | 54 | I/O | Test data output port. TDO/TDI data output or programming data input terminal. |
| TMS | 56 | I | Test mode select. TMS is used as an input port for device programming and test. |
| XIN | 8 | I | Input port for crystal oscillator XT1. Standard or watch crystals can be connected. |
| XOUT | 9 | O | Output terminal of crystal oscillator XT1. |

Short-Form Description

CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter, stack pointer, status register, and constant generator, respectively. The remaining registers are general-purpose registers.

Peripherals are connected to the CPU using data, address, and control buses, and can be handled with all instructions.

Instruction Set

The instruction set consists of the original 51 instructions with three formats and seven address modes. Each instruction can operate on word and byte data. [Table 2](#) shows examples of the three types of instruction formats; [Table 3](#) shows the address modes.

| | |
|--------------------------|-----------|
| Program Counter | PC/R0 |
| Stack Pointer | SP/R1 |
| Status Register | SR/CG1/R2 |
| Constant Generator | CG2/R3 |
| General-Purpose Register | R4 |
| General-Purpose Register | R5 |
| General-Purpose Register | R6 |
| General-Purpose Register | R7 |
| General-Purpose Register | R8 |
| General-Purpose Register | R9 |
| General-Purpose Register | R10 |
| General-Purpose Register | R11 |
| General-Purpose Register | R12 |
| General-Purpose Register | R13 |
| General-Purpose Register | R14 |
| General-Purpose Register | R15 |

Table 2. Instruction Word Formats

| INSTRUCTION FORMAT | EXAMPLE | OPERATION |
|-----------------------------------|-----------|---|
| Dual operands, source-destination | ADD R4,R5 | $R4 + R5 \rightarrow R5$ |
| Single operands, destination only | CALL R8 | $PC \rightarrow (TOS), R8 \rightarrow PC$ |
| Relative jump, un/conditional | JNE | Jump-on-equal bit = 0 |

Table 3. Address Mode Descriptions

| ADDRESS MODE | S ⁽¹⁾ | D ⁽¹⁾ | SYNTAX | EXAMPLE | OPERATION |
|------------------------|------------------|------------------|--------------------|-------------------|---|
| Register | • | • | MOV Rs, Rd | MOV R10, R11 | $R10 \rightarrow R11$ |
| Indexed | • | • | MOV X(Rn), Y(Rm) | MOV 2(R5), 6(R6) | $M(2+R5) \rightarrow M(6+R6)$ |
| Symbolic (PC relative) | • | • | MOV EDE, TONI | | $M(EDE) \rightarrow M(TONI)$ |
| Absolute | • | • | MOV & MEM, & TCDAT | | $M(MEM) \rightarrow M(TCDAT)$ |
| Indirect | • | | MOV @Rn, Y(Rm) | MOV @R10, Tab(R6) | $M(R10) \rightarrow M(Tab+R6)$ |
| Indirect autoincrement | • | | MOV @Rn+, Rm | MOV @R10+, R11 | $M(R10) \rightarrow R11$ $R10 + 2 \rightarrow R10$ |
| Immediate | • | | MOV #X, TONI | MOV #45, TONI | $\#45 \rightarrow M(TONI)$ |

(1) S = source D = destination

Operating Modes

The MSP430 has one active mode and five software-selectable low-power modes of operation. An interrupt event can wake up the device from any of the five low-power modes, service the request, and restore back to the low-power mode on return from the interrupt program.

The following six operating modes can be configured by software:

- Active mode (AM)
 - All clocks are active
- Low-power mode 0 (LPM0)
 - CPU is disabled
 - ACLK and SMCLK remain active, MCLK is available to modules
 - FLL+ loop control remains active
- Low-power mode 1 (LPM1)
 - CPU is disabled
 - ACLK and SMCLK remain active, MCLK is available to modules
 - FLL+ loop control is disabled
- Low-power mode 2 (LPM2)
 - CPU is disabled
 - MCLK, FLL+ loop control, and DCOCLK are disabled
 - DCO's dc-generator remains enabled
 - ACLK remains active
- Low-power mode 3 (LPM3)
 - CPU is disabled
 - MCLK, FLL+ loop control, and DCOCLK are disabled
 - DCO's dc-generator is disabled
 - ACLK remains active
- Low-power mode 4 (LPM4)
 - CPU is disabled
 - ACLK is disabled
 - MCLK, FLL+ loop control, and DCOCLK are disabled
 - DCO's dc-generator is disabled
 - Crystal oscillator is stopped

Interrupt Vector Addresses

The interrupt vectors and the power-up starting address are located in the address range 0FFFFh to 0FFE0h. The vector contains the 16-bit address of the appropriate interrupt-handler instruction sequence.

Table 4. Interrupt Sources, Flags, and Vectors

| INTERRUPT SOURCE | INTERRUPT FLAG | SYSTEM INTERRUPT | WORD ADDRESS | PRIORITY |
|---|--|---|--------------|-------------|
| Power-up External Reset Watchdog Flash memory | WDTIFG KEYV ⁽¹⁾ | Reset | 0FFFEh | 15, highest |
| NMI Oscillator Fault Flash memory access violation | NMIIFG OFIFG ACCVIFG ⁽¹⁾⁽²⁾ | (Non)maskable (Non)maskable (Non)maskable | 0FFFCCh | 14 |
| Timer1_A5 | TA1CCR0 CCIFG ⁽³⁾ | Maskable | 0FFFAh | 13 |
| Timer1_A5 | TA1CCR1 CCIFG to TA1CCR4 CCIFG, TA1CTL TAIFG ⁽¹⁾⁽³⁾ | Maskable | 0FFF8h | 12 |
| Comparator_A | CMPIFG | Maskable | 0FFF6h | 11 |
| Watchdog Timer | WDTIFG | Maskable | 0FFF4h | 10 |
| Scan IF | SIFIFG0 to SIFIFG6 ⁽¹⁾ | Maskable | 0FFF2h | 9 |
| | | | 0FFF0h | 8 |
| | | | 0FFEEh | 7 |
| Timer0_A3 | TA0CCR0 CCIFG ⁽³⁾ | Maskable | 0FFECCh | 6 |
| Timer0_A3 | TA0CCR1 CCIFG, TA0CCR2 CCIFG, TA0CTL TAIFG ⁽¹⁾⁽²⁾ | Maskable | 0FFEAh | 5 |
| I/O port P1 (eight flags) | P1IFG.0 to P1IFG.7 ⁽¹⁾⁽²⁾ | Maskable | 0FFE8h | 4 |
| | | | 0FFE6h | 3 |
| | | | 0FFE4h | 2 |
| I/O port P2 (eight flags) | P2IFG.0 to P2IFG.7 ⁽¹⁾⁽²⁾ | Maskable | 0FFE2h | 1 |
| Basic Timer1 | BTIFG | Maskable | 0FFE0h | 0, lowest |

(1) Multiple source flags

(2) (Non)maskable: the individual interrupt-enable bit can disable an interrupt event, but the general interrupt-enable cannot.

(3) Interrupt flags are located in the module.

Special Function Registers

Most interrupt and module-enable bits are collected in the lowest address space. Special-function register bits not allocated to a functional purpose are not physically present in the device. This arrangement provides simple software access.

Interrupt Enable 1 and 2

| Address | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------|------|---|--------|-------|---|---|------|-------|
| 00h | | | ACCVIE | NMIIE | | | OFIE | WDTIE |
| | | | rw-0 | rw-0 | | | rw-0 | rw-0 |
| Address | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| 01h | BTIE | | | | | | | |
| | rw-0 | | | | | | | |

WDTIE: Watchdog-timer interrupt enable. Inactive if watchdog mode is selected. Active if watchdog timer is configured in interval timer mode.

OFIE: Oscillator-fault-interrupt enable

NMIIE: Nonmaskable-interrupt enable

ACCVIE: Flash access violation interrupt enable

BTIE: Basic Timer1 interrupt enable

Interrupt Flag Register 1 and 2

| Address | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------|-------|---|---|--------|---|---|-------|--------|
| 02h | | | | NMIIFG | | | OFIFG | WDTIFG |
| | | | | rw-0 | | | rw-1 | rw-(0) |
| Address | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| 03h | BTIFG | | | | | | | |
| | rw-0 | | | | | | | |

WDTIFG: Set on watchdog timer overflow (in watchdog mode) or security key violation. Reset on V_{CC} power up or a reset condition at the RST/NMI pin in reset mode

OFIFG: Flag set on oscillator fault

NMIIFG: Set via RST/NMI pin

BTIFG: Basic Timer1 interrupt flag


Module Enable Registers 1 and 2

| Address | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|---------|---|---|---|---|---|---|---|---|
| 04h/05h | | | | | | | | |

Legend rw: Bit can be Read and Written.

rw-0,1: Bit can be Read and Written. It is Reset or Set by PUC.

rw-(0,1): Bit can be Read and Written. It is Reset or Set by POR.

 SFR bit is not present in device

Memory Organization

Table 5. Memory Organization

| | | MSP430FW423 | MSP430FW425 | MSP430FW427 | MSP430FW428 | MSP430FW429 |
|--------------------|-----------|--------------------|--------------------|--------------------|--------------------|--------------------|
| Memory | Size | 8KB | 16KB | 32KB | 48KB | 60KB |
| Interrupt vector | Flash | 0FFFFh-0FFE0h | 0FFFFh-0FFE0h | 0FFFFh-0FFE0h | 0FFFFh-0FFE0h | 0FFFFh-0FFE0h |
| Code memory | Flash | 0FFFFh - 0E000h | 0FFFFh-0C000h | 0FFFFh-08000h | 0FFFFh-04000h | 0FFFFh-01100h |
| Information memory | Size | 256 Byte | 256 Byte | 256 Byte | 256 Byte | 256 Byte |
| | | 010FFh-01000h | 010FFh-01000h | 010FFh-01000h | 010FFh-01000h | 010FFh-01000h |
| Boot memory | Size | 1KB | 1KB | 1KB | 1KB | 1KB |
| | | 0FFFh-0C00h | 0FFFh-0C00h | 0FFFh-0C00h | 0FFFh-0C00h | 0FFFh-0C00h |
| RAM | Size | 256 Byte | 512 Byte | 1KB | 2KB | 2KB |
| | | 02FFh-0200h | 03FFh-0200h | 05FFh-0200h | 09FFh-0200h | 09FFh-0200h |
| Peripherals | 16-bit | 01FFh-0100h | 01FFh - 0100h | 01FFh-0100h | 01FFh-0100h | 01FFh-0100h |
| | 8-bit | 0FFh-010h | 0FFh-010h | 0FFh-010h | 0FFh-010h | 0FFh-010h |
| | 8-bit SFR | 0Fh-00h | 0Fh-00h | 0Fh - 00h | 0Fh-00h | 0Fh-00h |

Bootstrap Loader (BSL)

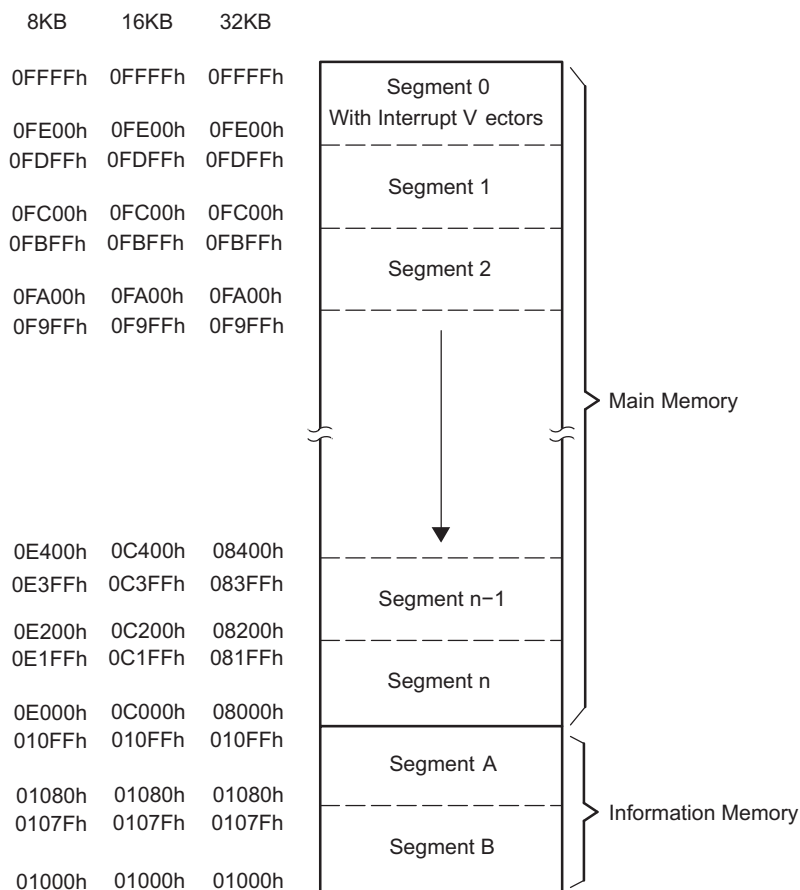
The MSP430 bootstrap loader (BSL) enables users to program the flash memory or RAM using a UART serial interface. Access to the MSP430 memory via the BSL is protected by user-defined password. For complete description of the features of the BSL and its implementation, see the *MSP430 Programming Via the Bootstrap Loader User's Guide* ([SLAU319](#)).

| BSL FUNCTION | PM PACKAGE PINS |
|---------------------|------------------------|
| Data Transmit | 53 - P1.0 |
| Data Receiver | 52 - P1.1 |

Flash Memory

The flash memory can be programmed via the JTAG port, the bootstrap loader, or in system by the CPU. The CPU can perform single-byte and single-word writes to the flash memory. Features of the flash memory include:

- Flash memory has n segments of main memory and two segments of information memory (A and B) of 128 bytes each. Each segment in main memory is 512 bytes in size.
- Segments 0 to n may be erased in one step, or each segment may be individually erased.
- Segments A and B can be erased individually, or as a group with segments 0 to n. Segments A and B are also called *information memory*.
- New devices may have some bytes programmed in the information memory (needed for test during manufacturing). The user should perform an erase of the information memory prior to the first use.



Peripherals

Peripherals are connected to the CPU through data, address, and control buses and can be handled using all instructions. For complete module descriptions, refer to the *MSP430x4xx Family User's Guide* (SLAU056).

Oscillator and System Clock

The clock system is supported by the FLL+ module that includes support for a 32768-Hz watch crystal oscillator, an internal digitally controlled oscillator (DCO), and a high-frequency crystal oscillator. The FLL+ clock module is designed to meet the requirements of both low system cost and low power consumption. The FLL+ features digital frequency locked loop (FLL) hardware that, in conjunction with a digital modulator, stabilizes the DCO frequency to a programmable multiple of the watch crystal frequency. The internal DCO provides a fast turn-on clock source and stabilizes in less than 6 μ s. The FLL+ module provides the following clock signals:

- Auxiliary clock (ACLK), sourced from a 32768-Hz watch crystal or a high frequency crystal.
- Main clock (MCLK), the system clock used by the CPU.
- Sub-Main clock (SMCLK), the subsystem clock used by the peripheral modules.
- ACLK/n, the buffered output of ACLK, ACLK/2, ACLK/4, or ACLK/8.

Brownout, Supply Voltage Supervisor (SVS)

The brownout circuit is implemented to provide the proper internal reset signal to the device during power-on and power-off. The SVS circuitry detects if the supply voltage drops below a user-selectable level and supports both supply voltage supervision (the device is automatically reset) and supply voltage monitoring (the device is not automatically reset).

The CPU begins code execution after the brownout circuit releases the device reset. However, V_{CC} may not have ramped to $V_{CC(min)}$ at that time. The user must insure the default FLL+ settings are not changed until V_{CC} reaches $V_{CC(min)}$. If desired, the SVS circuit can be used to determine when V_{CC} reaches $V_{CC(min)}$.

Digital I/O

There are six 8-bit I/O ports implemented—ports P1 through P6:

- All individual I/O bits are independently programmable.
- Any combination of input, output, and interrupt conditions is possible.
- Edge-selectable interrupt input capability for all the eight bits of ports P1 and P2.
- Read/write access to port-control registers is supported by all instructions.

Basic Timer1

The Basic Timer1 has two independent 8-bit timers that can be cascaded to form a 16-bit timer/counter. Both timers can be read and written by software. The Basic Timer1 can be used to generate periodic interrupts and clock for the LCD module.

LCD Drive

The LCD driver generates the segment and common signals required to drive an LCD display. The LCD controller has dedicated data memory to hold segment drive information. Common and segment signals are generated as defined by the mode. Static, 2-MUX, 3-MUX, and 4-MUX LCDs are supported by this peripheral.

Watchdog Timer (WDT)

The primary function of the WDT module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as an interval timer and can generate interrupts at selected time intervals.

Comparator_A

The primary function of the Comparator_A module is to support precision slope analog-to-digital conversions, battery-voltage supervision, and monitoring of external analog signals.

Scan Interface

The scan interface is used to measure linear or rotational motion and supports LC and resistive sensors such as GMR sensors. The scan IF incorporates a $V_{CC}/2$ generator, a comparator, and a 10-bit DAC and supports up to four sensors.

Timer0_A3

Timer0_A3 is a 16-bit timer/counter with three capture/compare registers. Timer_A3 can support multiple capture/compares, PWM outputs, and interval timing. Timer0_A3 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers.

Table 6. Timer0_A3 Signal Connections

| INPUT PIN NUMBER | DEVICE INPUT SIGNAL | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | OUTPUT PIN NUMBER |
|------------------|---------------------|-------------------|--------------|----------------------|-------------------|
| 48 - P1.5 | TA0CLK | TACLK | Timer | NA | |
| | ACLK | ACLK | | | |
| | SMCLK | SMCLK | | | |
| 48 - P1.5 | TA0CLK | INCLK | | | |
| 53 - P1.0 | TA0.0 | CCI0A | CCR0 | TA0.0 | 53 - P1.0 |
| 52 - P1.1 | TA0.0 | CCI0B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 51 - P1.2 | TA0.1 | CCI1A | CCR1 | TA0.1 | 51 - P1.2 |
| | CAOUT (internal) | CCI1B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 45 - P2.0 | TA0.2 | CCI2A | CCR2 | TA0.2 | 45 - P2.0 |
| | ACLK (internal) | CCI2B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |

Timer1_A5

Timer1_A5 is a 16-bit timer/counter with five capture/compare registers. Timer1_A5 can support multiple capture/compares, PWM outputs, and interval timing. Timer1_A5 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers.

Table 7. Timer1_A5 Signal Connections

| INPUT PIN NUMBER | DEVICE INPUT SIGNAL | MODULE INPUT NAME | MODULE BLOCK | MODULE OUTPUT SIGNAL | OUTPUT PIN NUMBER |
|------------------|---------------------|-------------------|--------------|----------------------|-------------------|
| 32 - P2.5 | TA1CLK | TACLK | Timer | NA | |
| | ACLK | ACLK | | | |
| | SMCLK | SMCLK | | | |
| 32 - P2.5 | TA1CLK | INCLK | | | |
| 49 - P1.4 | TA1.0 | CCI0A | CCR0 | TA1.0 | 49 - P1.4 |
| 50 - P1.3 | TA1.0 | CCI0B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 44 - P2.1 | TA1.1 | CCI1A | CCR1 | TA1.1 | 44 - P2.1 |
| | CAOUT (internal) | CCI1B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 35 - P2.2 | TA1.2 | CCI2A | CCR2 | TA1.2 | 35 - P2.2 |
| | SIFO0sig (internal) | CCI2B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 34 - P2.3 | TA1.3 | CCI3A | CCR3 | TA1.3 | 34 - P2.3 |
| | SIFO1sig (internal) | CCI3B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |
| 33 - P2.4 | TA1.4 | CCI4A | CCR4 | TA1.4 | 33 - P2.4 |
| | SIFO2sig (internal) | CCI4B | | | |
| | DV _{SS} | GND | | | |
| | DV _{CC} | V _{CC} | | | |

Peripheral File Map

Table 8. Peripherals With Word Access

| MODULE | REGISTER NAME | ACRONYM | ADDRESS |
|-----------|----------------------------|----------|---------|
| Watchdog | Watchdog Timer control | WDTCTL | 0120h |
| Timer1_A5 | Timer1_A interrupt vector | TA1IV | 011Eh |
| | Timer1_A control | TA1CTL | 0180h |
| | Capture/compare control 0 | TA1CCTL0 | 0182h |
| | Capture/compare control 1 | TA1CCTL1 | 0184h |
| | Capture/compare control 2 | TA1CCTL2 | 0186h |
| | Capture/compare control 3 | TA1CCTL3 | 0188h |
| | Capture/compare control 4 | TA1CCTL4 | 018Ah |
| | Reserved | | 018Ch |
| | Reserved | | 018Eh |
| | Timer1_A register | TA1R | 0190h |
| | Capture/compare register 0 | TA1CCR0 | 0192h |
| | Capture/compare register 1 | TA1CCR1 | 0194h |
| | Capture/compare register 2 | TA1CCR2 | 0196h |
| | Capture/compare register 3 | TA1CCR3 | 0198h |
| | Capture/compare register 4 | TA1CCR4 | 019Ah |
| | Reserved | | 019Ch |
| | Reserved | | 019Eh |
| Timer0_A3 | Timer0_A interrupt vector | TA0IV | 012Eh |
| | Timer0_A control | TA0CTL0 | 0160h |
| | Capture/compare control 0 | TA0CCTL0 | 0162h |
| | Capture/compare control 1 | TA0CCTL1 | 0164h |
| | Capture/compare control 2 | TA0CCTL2 | 0166h |
| | Reserved | | 0168h |
| | Reserved | | 016Ah |
| | Reserved | | 016Ch |
| | Reserved | | 016Eh |
| | Timer0_A register | TA0R | 0170h |
| | Capture/compare register 0 | TA0CCR0 | 0172h |
| | Capture/compare register 1 | TA0CCR1 | 0174h |
| | Capture/compare register 2 | TA0CCR2 | 0176h |
| | Reserved | | 0178h |
| | Reserved | | 017Ah |
| | Reserved | | 017Ch |
| | Reserved | | 017Eh |
| Flash | Flash control 3 | FCTL3 | 012Ch |
| | Flash control 2 | FCTL2 | 012Ah |
| | Flash control 1 | FCTL1 | 0128h |

Table 8. Peripherals With Word Access (continued)

| MODULE | REGISTER NAME | ACRONYM | ADDRESS |
|---------|-------------------------------------|----------|---------|
| Scan IF | SIF timing state machine 23 | SIFTSM23 | 01FEh |
| | ⋮ | ⋮ | ⋮ |
| | SIF timing state machine 0 | SIFTSM0 | 01D0h |
| | SIF DAC register 7 | SIFDACR7 | 01CEh |
| | ⋮ | ⋮ | ⋮ |
| | SIF DAC register 0 | SIFDACR0 | 01C0h |
| | SIF control register 5 | SIFCTL5 | 01BEh |
| | SIF control register 4 | SIFCTL4 | 01BCh |
| | SIF control register 3 | SIFCTL3 | 01BAh |
| | SIF control register 2 | SIFCTL2 | 01B8h |
| | SIF control register 1 | SIFCTL1 | 01B6h |
| | SIF processing state machine vector | SIFPSMV | 01B4h |
| | SIF counter CNT1/2 | SIFCNT | 01B2h |
| | Reserved | SIFDEBUG | 01B0h |

Table 9. Peripherals With Byte Access

| MODULE | REGISTER NAME | ACRONYM | ADDRESS |
|---------------|-----------------------------------|----------|---------|
| LCD | LCD memory 20 | LCDM20 | 0A4h |
| | ⋮ | ⋮ | ⋮ |
| | LCD memory 16 | LCDM16 | 0A0h |
| | LCD memory 15 | LCDM15 | 09Fh |
| | ⋮ | ⋮ | ⋮ |
| | LCD memory 1 | LCDM1 | 091h |
| | LCD control and mode | LCDCTL | 090h |
| Comparator_A | Comparator_A port disable | CAPD | 05Bh |
| | Comparator_A control 2 | CACTL2 | 05Ah |
| | Comparator_A control 1 | CACTL1 | 059h |
| Brownout, SVS | SVS control register | SVSCTL | 056h |
| FLL+ Clock | FLL+ Control 1 | FLL_CTL1 | 054h |
| | FLL+ Control 0 | FLL_CTL0 | 053h |
| | System clock frequency control | SCFQCTL | 052h |
| | System clock frequency integrator | SCFI1 | 051h |
| | System clock frequency integrator | SCFI0 | 050h |
| Basic Timer1 | BT counter 2 | BTCNT2 | 047h |
| | BT counter 1 | BTCNT1 | 046h |
| | BT control | BTCTL | 040h |
| Port P6 | Port P6 selection | P6SEL | 037h |
| | Port P6 direction | P6DIR | 036h |
| | Port P6 output | P6OUT | 035h |
| | Port P6 input | P6IN | 034h |
| Port P5 | Port P5 selection | P5SEL | 033h |
| | Port P5 direction | P5DIR | 032h |
| | Port P5 output | P5OUT | 031h |
| | Port P5 input | P5IN | 030h |

Table 9. Peripherals With Byte Access (continued)

| MODULE | REGISTER NAME | ACRONYM | ADDRESS |
|-------------------|-------------------------------|---------|---------|
| Port P4 | Port P4 selection | P4SEL | 01Fh |
| | Port P4 direction | P4DIR | 01Eh |
| | Port P4 output | P4OUT | 01Dh |
| | Port P4 input | P4IN | 01Ch |
| Port P3 | Port P3 selection | P3SEL | 01Bh |
| | Port P3 direction | P3DIR | 01Ah |
| | Port P3 output | P3OUT | 019h |
| | Port P3 input | P3IN | 018h |
| Port P2 | Port P2 selection | P2SEL | 02Eh |
| | Port P2 interrupt enable | P2IE | 02Dh |
| | Port P2 interrupt-edge select | P2IES | 02Ch |
| | Port P2 interrupt flag | P2IFG | 02Bh |
| | Port P2 direction | P2DIR | 02Ah |
| | Port P2 output | P2OUT | 029h |
| | Port P2 input | P2IN | 028h |
| | | | |
| Port P1 | Port P1 selection | P1SEL | 026h |
| | Port P1 interrupt enable | P1IE | 025h |
| | Port P1 interrupt-edge select | P1IES | 024h |
| | Port P1 interrupt flag | P1IFG | 023h |
| | Port P1 direction | P1DIR | 022h |
| | Port P1 output | P1OUT | 021h |
| | Port P1 input | P1IN | 020h |
| | | | |
| Special Functions | SFR module enable 2 | ME2 | 005h |
| | SFR module enable 1 | ME1 | 004h |
| | SFR interrupt flag 2 | IFG2 | 003h |
| | SFR interrupt flag 1 | IFG1 | 002h |
| | SFR interrupt enable 2 | IE2 | 001h |
| | SFR interrupt enable 1 | IE1 | 000h |

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | | |
|---|---------------------|----------------------------|
| Voltage applied at V_{CC} to V_{SS} | | -0.3 V to 4.1 V |
| Voltage applied to any pin ⁽²⁾ | | -0.3 V to $V_{CC} + 0.3$ V |
| Diode current at any device terminal | | ± 2 mA |
| Storage temperature range, T_{stg} | Unprogrammed device | -55°C to 150°C |
| | Programmed device | -40°C to 85°C |

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages referenced to V_{SS} . The JTAG fuse-blow voltage, V_{FB} , is allowed to exceed the absolute maximum rating. The voltage is applied to the TDI/TCLK pin when blowing the JTAG fuse.

Recommended Operating Conditions

Typical values are specified at $V_{CC} = 3.3$ V and $T_A = 25^\circ\text{C}$ (unless otherwise noted)

| | | MIN | NOM | MAX | UNIT |
|----------------|--|---------------------------|-------------------|--------|------|
| V_{CC} | Supply voltage during program execution ⁽¹⁾ ($AV_{CC} = DV_{CC1} = DV_{CC2} = V_{CC}$) | 1.8 | | 3.6 | V |
| V_{CC} | Supply voltage during program execution, SVS enabled, PORON = 1 ⁽¹⁾ ⁽²⁾ ($AV_{CC} = DV_{CC1} = DV_{CC2} = V_{CC}$) | 2 | | 3.6 | V |
| V_{CC} | Supply voltage during flash memory programming ⁽¹⁾ ($AV_{CC} = DV_{CC1} = DV_{CC2} = V_{CC}$) | 2.7 | | 3.6 | V |
| V_{SS} | Supply voltage ($AV_{SS} = DV_{SS1} = DV_{SS2} = V_{SS}$) | 0 | | 0 | V |
| T_A | Operating free-air temperature range | -40 | | 85 | °C |
| $f_{(LFXT1)}$ | LFXT1 crystal frequency ⁽³⁾ | LF selected, XTS_FLL = 0 | Watch crystal | 32.768 | kHz |
| | | XT1 selected, XTS_FLL = 1 | Ceramic resonator | 450 | |
| | | XT1 selected, XTS_FLL = 1 | Crystal | 1000 | |
| $f_{(System)}$ | Processor frequency (signal MCLK) | $V_{CC} = 1.8$ V | DC | 4.15 | MHz |
| | | $V_{CC} = 3.6$ V | DC | 8 | |

- (1) It is recommended to power AV_{CC} and DV_{CC} from the same source. A maximum difference of 0.3 V between AV_{CC} and DV_{CC} can be tolerated during power up and operation.
- (2) The minimum operating supply voltage is defined according to the trip point where POR is going active by decreasing the supply voltage. POR is going inactive when the supply voltage is raised above the minimum supply voltage plus the hysteresis of the SVS circuitry.
- (3) In LF mode, the LFXT1 oscillator requires a watch crystal. In XT1 mode, LFXT1 accepts a ceramic resonator or a crystal.

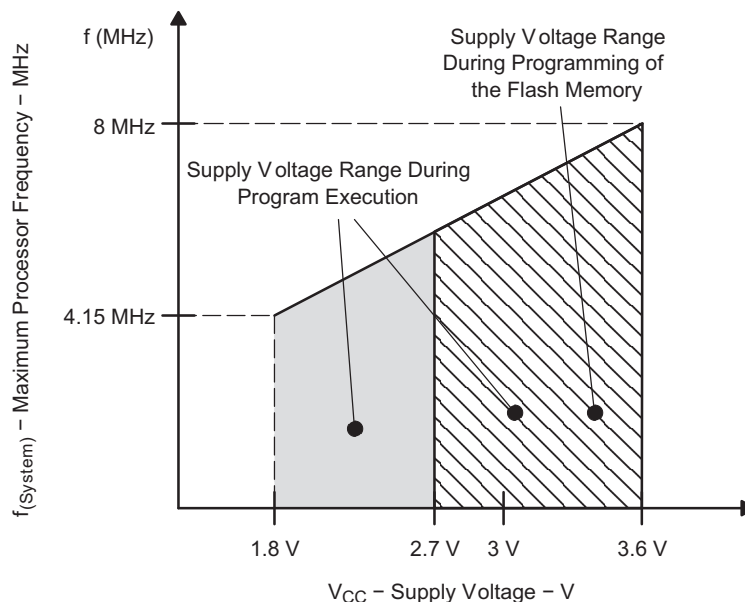


Figure 1. Maximum Frequency vs Supply Voltage

Electrical Characteristics

Supply Current Into $AV_{CC} + DV_{CC}$ Excluding External Current (FW423, FW425, FW427)⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | T_A | V_{CC} | MIN | TYP | MAX | UNIT |
|--------------|---|---|------------|-----|------|-----|---------------|
| $I_{(AM)}$ | Active mode (AM) $f_{(MCLK)} = f_{(SMCLK)} = f_{(DCO)} = 1 \text{ MHz}$, $f_{(ACLK)} = 32768 \text{ Hz}$, $XTS_FLL = 0$ | -40°C to 85°C | 2.2 V | | 200 | 250 | μA |
| | | | 3 V | | 300 | 350 | |
| $I_{(LPM0)}$ | Low-power mode 0 (LPM0) ⁽²⁾ $f_{(MCLK)} = f_{(SMCLK)} = f_{(DCO)} = 1 \text{ MHz}$, $f_{(ACLK)} = 32768 \text{ Hz}$, $XTS_FLL = 0$, $FN_8 = FN_4 = FN_3 = FN_2 = 0$ | -40°C to 85°C | 2.2 V | | 57 | 70 | μA |
| | | | 3 V | | 92 | 100 | |
| $I_{(LPM2)}$ | Low-power mode 2 (LPM2) ⁽²⁾ | -40°C to 85°C | 2.2 V | | 11 | 14 | μA |
| | | | 3 V | | 17 | 22 | |
| $I_{(LPM3)}$ | Low-power mode 3 (LPM3) ⁽³⁾⁽²⁾ | -40°C | 2.2 V | | 0.95 | 1.4 | μA |
| | | -10°C | | | 0.8 | 1.3 | |
| | | 25°C | | | 0.7 | 1.2 | |
| | | 60°C | | | 0.95 | 1.4 | |
| | | 85°C | | | 1.6 | 2.3 | |
| | | -40°C | 3 V | | 1.1 | 1.7 | |
| | | -10°C | | | 1 | 1.6 | |
| | | 25°C | | | 0.9 | 1.5 | |
| | | 60°C | | | 1.1 | 1.7 | |
| | | 85°C | | | 2 | 2.6 | |
| $I_{(LPM4)}$ | Low-power mode (LPM4) ⁽²⁾ | -40°C | 2.2 V, 3 V | | 0.1 | 0.5 | μA |
| | | 25°C | | | 0.1 | 0.5 | |
| | | 85°C | | | 0.8 | 2.5 | |

(1) All inputs are tied to 0 V or V_{CC} . Outputs do not source or sink any current. The current consumption is measured with active Basic Timer1 and LCD (ACLK selected). The current consumption of the Comparator_A and the SVS module are specified in the respective sections.

(2) Current consumption for brownout included.

(3) The LPM3 currents are characterized with a KDS Daishinku DT-38 (6 pF) crystal.

Supply Current Into AV_{CC} + DV_{CC} Excluding External Current (FW428, FW429)⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | T _A | V _{CC} | MIN | TYP | MAX | UNIT |
|---------------------|---|----------------|-----------------|-----|------|------|------|
| I _(AM) | Active mode (AM) f _(MCLK) = f _(SMCLK) = f _(DCO) = 1 MHz, f _(ACLK) = 32768 Hz, XTS_FLL = 0 | -40°C to 85°C | 2.2 V | | 210 | 290 | μA |
| | | | 3 V | | 320 | 390 | |
| I _(LPM0) | Low-power mode 0 (LPM0) ⁽²⁾ f _(MCLK) = f _(SMCLK) = f _(DCO) = 1 MHz, f _(ACLK) = 32768 Hz, XTS_FLL = 0, FN_8 = FN_4 = FN_3 = FN_2 = 0 | -40°C to 85°C | 2.2 V | | 60 | 75 | μA |
| | | | 3 V | | 95 | 110 | |
| I _(LPM2) | Low-power mode 2 (LPM2) ⁽²⁾ | -40°C to 85°C | 2.2 V | | 11 | 14 | μA |
| | | | 3 V | | 17 | 22 | |
| I _(LPM3) | Low-power mode 3 (LPM3) ⁽³⁾⁽²⁾ | -40°C | 2.2 V | | 0.95 | 1.4 | μA |
| | | -10°C | | | 0.8 | 1.3 | |
| | | 25°C | | | 0.7 | 1.5 | |
| | | 60°C | | | 1.0 | 1.9 | |
| | | 85°C | | | 1.7 | 2.9 | |
| | | -40°C | 3 V | | 1.1 | 1.7 | μA |
| | | -10°C | | | 1.0 | 1.6 | |
| | | 25°C | | | 0.9 | 1.85 | |
| | | 60°C | | | 1.3 | 2.6 | |
| | | 85°C | | | 2.1 | 3.9 | |
| I _(LPM4) | Low-power mode (LPM4) ⁽²⁾ | -40°C | 2.2 V, 3 V | | 0.1 | 0.5 | μA |
| | | 25°C | | | 0.15 | 0.5 | |
| | | 85°C | | | 1.3 | 2.5 | |

(1) All inputs are tied to 0 V or V_{CC}. Outputs do not source or sink any current. The current consumption is measured with active Basic Timer1 and LCD (ACLK selected). The current consumption of the Comparator_A and the SVS module are specified in the respective sections.

(2) Current consumption for brownout included.

(3) The LPM3 currents are characterized with a KDS Daishinku DT-38 (6 pF) crystal.

Current consumption of active mode versus system frequency

$$I_{(AM)} = I_{(AM)} [1 \text{ MHz}] \times f_{(\text{System})} [\text{MHz}]$$

Current consumption of active mode versus supply voltage

$$I_{(AM)} = I_{(AM)} [3 \text{ V}] + 140 \mu\text{A/V} \times (V_{CC} - 3 \text{ V})$$

Schmitt-Trigger Inputs – Ports (P1, P2, P3, P4, P5, P6), $\overline{\text{RST}}/\text{NMI}$, JTAG (TCK, TMS, TDI/TCLK)

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------|--|--------------------------|------|-----|-----|------|
| V_{IT+} | Positive-going input threshold voltage | $V_{CC} = 2.2 \text{ V}$ | 1.1 | | 1.5 | V |
| | | $V_{CC} = 3 \text{ V}$ | 1.5 | | 1.9 | |
| V_{IT-} | Negative-going input threshold voltage | $V_{CC} = 2.2 \text{ V}$ | 0.4 | | 0.9 | V |
| | | $V_{CC} = 3 \text{ V}$ | 0.9 | | 1.3 | |
| V_{hys} | Input voltage hysteresis ($V_{IT+} - V_{IT-}$) | $V_{CC} = 2.2 \text{ V}$ | 0.3 | | 1.1 | V |
| | | $V_{CC} = 3 \text{ V}$ | 0.45 | | 1 | |

Inputs Px.x, TAxx

| PARAMETER | | TEST CONDITIONS | V_{CC} | MIN | TYP | MAX | UNIT |
|---------------|---|--|------------|-----|-----|-----|-------|
| $t_{(int)}$ | External interrupt timing | Port P1, P2: P1.x to P2.x, external trigger signal for the interrupt flag ⁽¹⁾ | 2.2 V, 3 V | 1.5 | | | cycle |
| | | | 2.2 V | 62 | | | ns |
| | | | 3 V | 50 | | | |
| $t_{(cap)}$ | Timer_A capture timing | TAxx x | 2.2 V | 62 | | | ns |
| | | | 3 V | 50 | | | |
| $f_{(TAext)}$ | Timer_A clock frequency externally applied to pin | TAxCLK, INCLK $t_{(H)} = t_{(L)}$ | 2.2 V | | | 8 | MHz |
| | | | 3 V | | | 10 | |
| $f_{(TAint)}$ | Timer_A clock frequency | SMCLK or ACLK signal selected | 2.2 V | | | 8 | MHz |
| | | | 3 V | | | 10 | |

(1) The external signal sets the interrupt flag every time the minimum $t_{(int)}$ parameters are met. It may be set even with trigger signals shorter than $t_{(int)}$. Both the cycle and timing specifications must be met to ensure the flag is set. $t_{(int)}$ is measured in MCLK cycles.

Leakage Current – Ports (P1, P2, P3, P4, P5, P6)⁽¹⁾

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------|-----------------|---|-----|-----|-----|------|
| $I_{lkg}(P_{x.x})$ | Leakage current | Port P1.x: $V_{(P_{x.x})}$ ⁽²⁾ , $V_{CC} = 2.2 \text{ V}, 3 \text{ V}$ | | | ±50 | nA |

(1) The leakage current is measured with V_{SS} or V_{CC} applied to the corresponding pins, unless otherwise noted.

(2) The port pin must be selected as input.

Outputs – Ports (P1, P2, P3, P4, P5, P6)

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------------|--|-----------------|-----|-----------------|------|
| V_{OH} High-level output voltage | $I_{OH(max)} = -1.5 \text{ mA}$, $V_{CC} = 2.2 \text{ V}^{(1)}$ | $V_{CC} - 0.25$ | | V_{CC} | V |
| | $I_{OH(max)} = -6 \text{ mA}$, $V_{CC} = 2.2 \text{ V}^{(2)}$ | $V_{CC} - 0.6$ | | V_{CC} | |
| | $I_{OH(max)} = -1.5 \text{ mA}$, $V_{CC} = 3 \text{ V}^{(1)}$ | $V_{CC} - 0.25$ | | V_{CC} | |
| | $I_{OH(max)} = -6 \text{ mA}$, $V_{CC} = 3 \text{ V}^{(2)}$ | $V_{CC} - 0.6$ | | V_{CC} | |
| V_{OL} Low-level output voltage | $I_{OL(max)} = 1.5 \text{ mA}$, $V_{CC} = 2.2 \text{ V}^{(1)}$ | V_{SS} | | $V_{SS} + 0.25$ | V |
| | $I_{OL(max)} = 6 \text{ mA}$, $V_{CC} = 2.2 \text{ V}^{(2)}$ | V_{SS} | | $V_{SS} + 0.6$ | |
| | $I_{OL(max)} = 1.5 \text{ mA}$, $V_{CC} = 3 \text{ V}^{(1)}$ | V_{SS} | | $V_{SS} + 0.25$ | |
| | $I_{OL(max)} = 6 \text{ mA}$, $V_{CC} = 3 \text{ V}^{(2)}$ | V_{SS} | | $V_{SS} + 0.6$ | |

- (1) The maximum total current, $I_{OH(max)}$ and $I_{OL(max)}$, for all outputs combined, should not exceed $\pm 12 \text{ mA}$ to satisfy the maximum specified voltage drop.
- (2) The maximum total current, $I_{OH(max)}$ and $I_{OL(max)}$, for all outputs combined, should not exceed $\pm 48 \text{ mA}$ to satisfy the maximum specified voltage drop.

Output Frequency

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|---------------------------------|----------------|-----|---------------|
| $f_{(Px.y)}$ ($1 \leq x \leq 6$, $0 \leq y \leq 7$) | $C_L = 20 \text{ F}$, $I_L = \pm 1.5 \text{ mA}$ | $V_{CC} = 2.2 \text{ V}$ | dc | 10 | MHz |
| | | $V_{CC} = 3 \text{ V}$ | dc | 12 | |
| $f_{(ACLK)}$ $f_{(MCLK)}$ $f_{(SMCLK)}$ | P1.1/TA0.0/MCLK, P1.5/TA0CLK/ACLK $C_L = 20 \text{ pF}$ | $V_{CC} = 2.2 \text{ V}$ | | 8 | MHz |
| | | $V_{CC} = 3 \text{ V}$ | | 12 | |
| $t_{(Xdc)}$ Duty cycle of output frequency | P1.5/TA0CLK/ACLK, $C_L = 20 \text{ pF}$ $V_{CC} = 2.2 \text{ V}, 3 \text{ V}$ | $f_{ACLK} = f_{LFX1} = f_{XT1}$ | 40% | 60% | |
| | | $f_{ACLK} = f_{LFX1} = f_{LF}$ | 30% | 70% | |
| | | $f_{ACLK} = f_{LFX1/n}$ | 50% | | |
| | P1.1/TA0.0/MCLK, $C_L = 20 \text{ pF}$ $V_{CC} = 2.2 \text{ V}, 3 \text{ V}$ | $f_{MCLK} = f_{LFX1/n}$ | 50% - 15 ns | 50% | 50%+ 15 ns |
| | | $f_{MCLK} = f_{DCOCLK}$ | 50% - 15 ns | 50% | 50%+ 15 ns |

TYPICAL LOW-LEVEL OUTPUT CURRENT
 vs
 LOW-LEVEL OUTPUT VOLTAGE

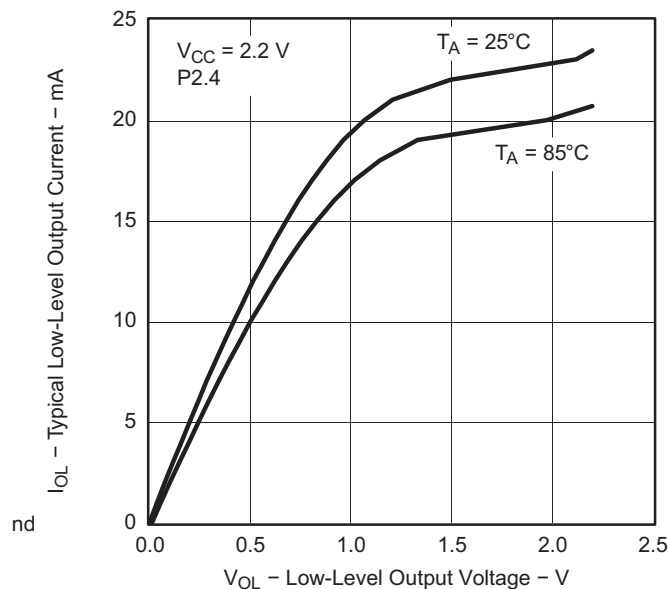


Figure 2.

TYPICAL LOW-LEVEL OUTPUT CURRENT
 vs
 LOW-LEVEL OUTPUT VOLTAGE

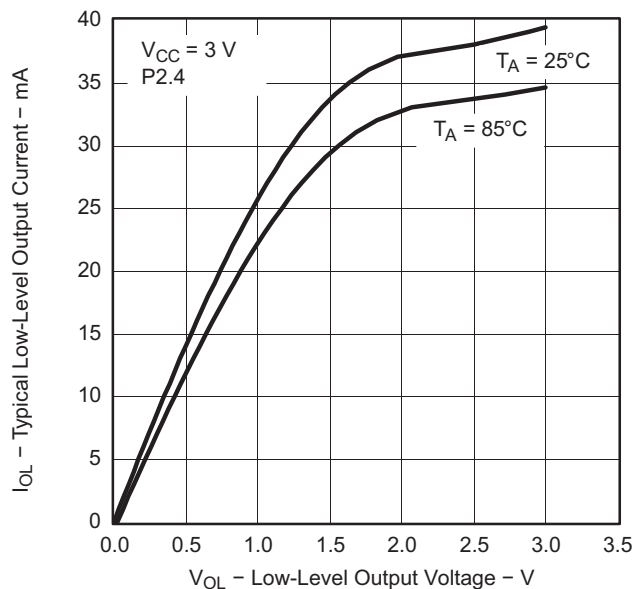


Figure 3.

TYPICAL HIGH-LEVEL OUTPUT CURRENT
 vs
 HIGH-LEVEL OUTPUT VOLTAGE

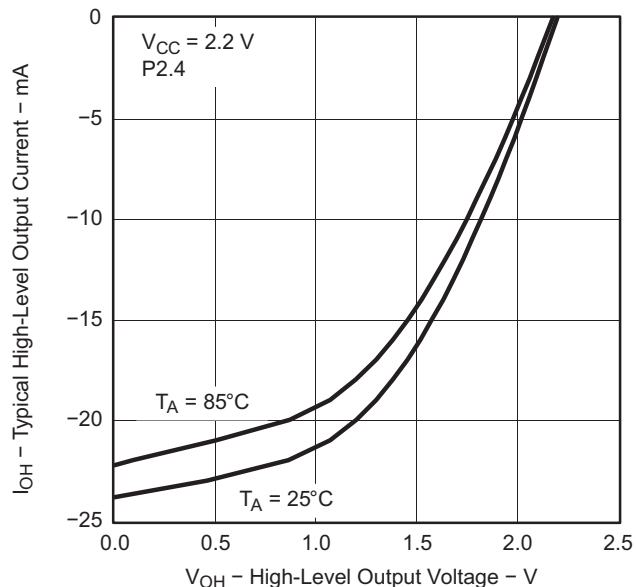


Figure 4.

TYPICAL HIGH-LEVEL OUTPUT CURRENT
 vs
 HIGH-LEVEL OUTPUT VOLTAGE

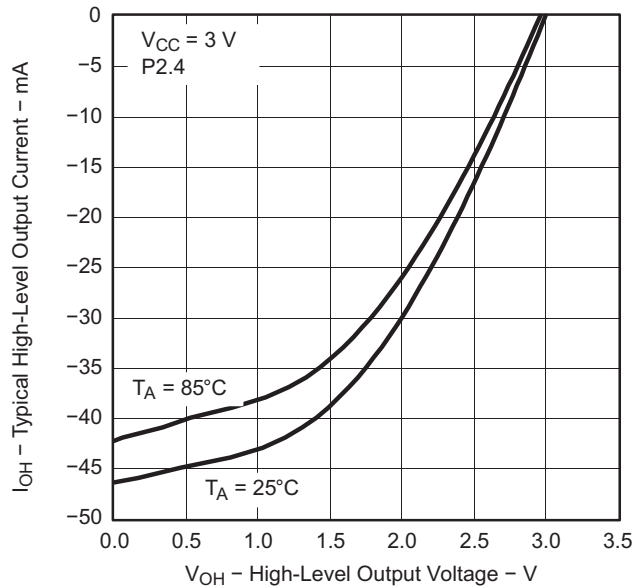


Figure 5.

Wake-UP LPM3

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|--------------------------|-----------------|-------------------------------------|-----|-----|-----|---------------|
| $t_{d(LPM3)}$ Delay time | f = 1 MHz | $V_{CC} = 2.2\text{ V}, 3\text{ V}$ | | | 6 | μs |
| | f = 2 MHz | | | | 6 | |
| | f = 3 MHz | | | | 6 | |

RAM

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------|---------------------------|-----|-----|-----|------|
| V_{RAMh} | CPU halted ⁽¹⁾ | 1.6 | | | V |

(1) This parameter defines the minimum supply voltage when the data in program memory RAM remain unchanged. No program execution should take place during this supply voltage condition.

LCD

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|-----------------------|----------------------|--------------------------------------|--|---|------------------|------|
| $V_{(33)}$ | Analog voltage | Voltage at P5.7/R33 | 2.5 | | $V_{CC} + 0.2$ | V |
| $V_{(23)}$ | | Voltage at P5.6/R23 | | $[V_{(33)} - V_{(03)}] \times \frac{2}{3} + V_{(03)}$ | | |
| $V_{(13)}$ | | Voltage at P5.5/R13 | | $[V_{(33)} - V_{(03)}] \times \frac{1}{3} + V_{(03)}$ | | |
| $V_{(33)} - V_{(03)}$ | | Voltage at R33 to R03 | 2.5 | | $V_{CC} + 0.2$ | |
| $I_{(R03)}$ | Input leakage | $R03 = V_{SS}$ | No load at all segment and common lines, $V_{CC} = 3\text{ V}$ | | ± 20 | nA |
| $I_{(R13)}$ | | $P5.5/R13 = V_{CC}/3$ | | | ± 20 | |
| $I_{(R23)}$ | | $P5.6/R23 = 2 \times V_{CC}/3$ | | | ± 20 | |
| $V_{(Sxx0)}$ | Segment line voltage | $I_{(Sxx)} = -3\text{ }\mu\text{A},$ | $V_{CC} = 3\text{ V}$ | $V_{(03)}$ | $V_{(03)} - 0.1$ | V |
| $V_{(Sxx1)}$ | | | | $V_{(13)}$ | $V_{(13)} - 0.1$ | |
| $V_{(Sxx2)}$ | | | | $V_{(23)}$ | $V_{(23)} - 0.1$ | |
| $V_{(Sxx3)}$ | | | | $V_{(33)}$ | $V_{(33)} + 0.1$ | |

Comparator_A⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|------------------------------------|--|--|------------|------|---------------------|------|
| I _(CC) | CAON = 1, CARSEL = 0, CAREF = 0 | 2.2 V | | 25 | 40 | μA |
| | | 3 V | | 45 | 60 | |
| I _(Ref ladder/RefDiode) | CAON = 1, CARSEL = 0, CAREF = 1/2/3, No load at P1.6/CA0 and P1.7/CA1 | 2.2 V | | 30 | 50 | μA |
| | | 3 V | | 45 | 71 | |
| V _(Ref025) | Voltage @ 0.25 V _{CC} node V _{CC} | PCA0 = 1, CARSEL = 1, CAREF = 1, No load at P1.6/CA0 and P1.7/CA1 | 2.2 V, 3 V | 0.23 | 0.24 | 0.25 |
| V _(Ref050) | Voltage @ 0.5 V _{CC} node V _{CC} | PCA0 = 1, CARSEL = 1, CAREF = 2, No load at P1.6/CA0 and P1.7/CA1 | 2.2 V, 3 V | 0.47 | 0.48 | 0.5 |
| V _(RefVT) | See Figure 6, Figure 7 PCA0 = 1, CARSEL = 1, CAREF = 3, No load at P1.6/CA0 and P1.7/CA1, T _A = 85°C | 2.2 V | 390 | 480 | 540 | mV |
| | | 3 V | 400 | 490 | 550 | |
| V _{IC} | Common-mode input voltage range | CAON = 1 | 2.2 V, 3 V | 0 | V _{CC} - 1 | V |
| V _p - V _s | Offset voltage | (2) | 2.2 V, 3 V | -30 | 30 | mV |
| V _{hys} | Input hysteresis | CAON = 1 | 2.2 V, 3 V | 0 | 0.7 | 1.4 |
| t _(response LH) | T _A = 25°C Overdrive 10 mV, without filter: CAF = 0 | 2.2 V | 130 | 210 | 300 | ns |
| | | 3 V | 80 | 150 | 240 | |
| | T _A = 25°C Overdrive 10 mV, with filter: CAF = 1 | 2.2 V | 1.4 | 1.9 | 3.4 | μs |
| | | 3 V | 0.9 | 1.5 | 2.6 | |
| t _(response HL) | T _A = 25°C Overdrive 10 mV, without filter: CAF = 0 | 2.2 V | 130 | 210 | 300 | ns |
| | | 3 V | 80 | 150 | 240 | |
| | T _A = 25°C Overdrive 10 mV, with filter: CAF = 1 | 2.2 V | 1.4 | 1.9 | 3.4 | μs |
| | | 3 V | 0.9 | 1.5 | 2.6 | |

(1) The leakage current for the Comparator_A terminals is identical to I_{lkg(Px.x)} specification.

(2) The input offset voltage can be cancelled by using the CAEX bit to invert the Comparator_A inputs on successive measurements. The two successive measurements are then summed together.

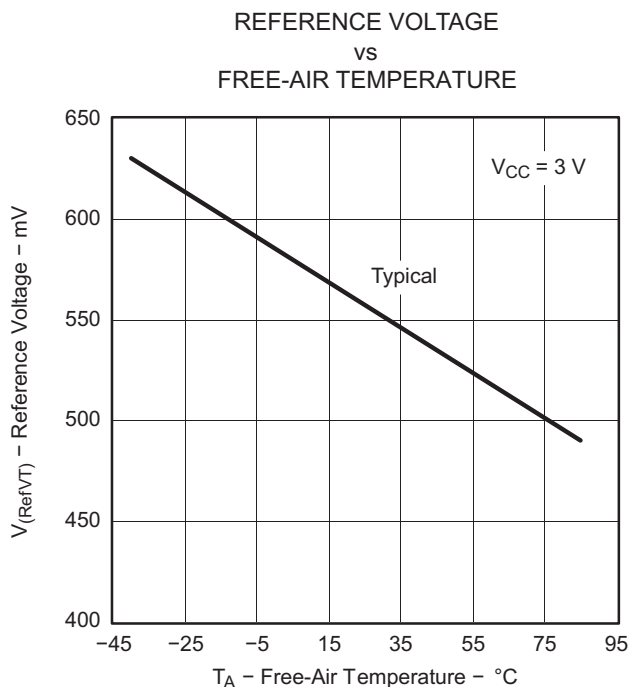


Figure 6.

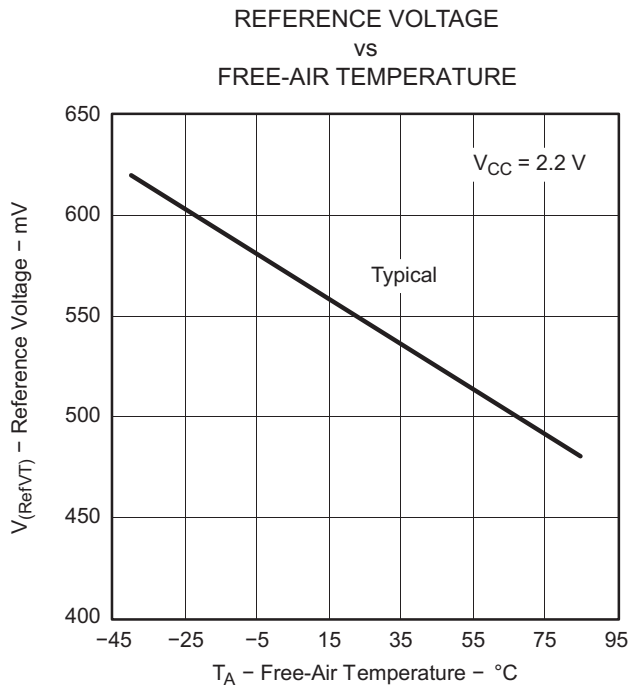


Figure 7.

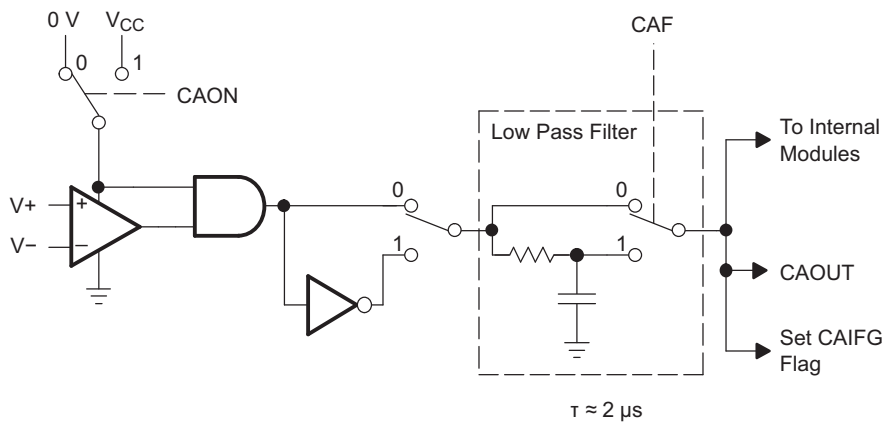


Figure 8. Block Diagram of Comparator_A Module

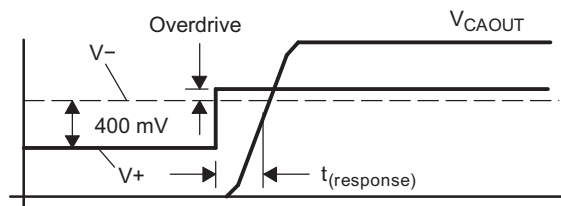


Figure 9. Overdrive Definition

POR, BOR ⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------------|---|-----|---------------------------|------|---------|
| $t_{d(BOR)}$ | | | | 2000 | μs |
| $V_{CC(start)}$ | $dV_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 10) | | $0.7 \times V_{(B_IT-)}$ | | V |
| $V_{(B_IT-)}$ | $dV_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 10 through Figure 12) | | | 1.71 | V |
| $V_{hys(B_IT-)}$ | $dV_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 10) | 70 | 130 | 210 | mV |
| $t_{(reset)}$ | Pulse duration needed at \overline{RST}/NMI pin to accepted reset internally, $V_{CC} = 2.2 \text{ V}, 3 \text{ V}$ | 2 | | | μs |

- (1) The current consumption of the brownout module is already included in the I_{CC} current consumption data. The voltage level $V_{(B_IT-)} + V_{hys(B_IT-)}$ is $\leq 1.8 \text{ V}$.
- (2) During power up, the CPU begins code execution following a period of $t_{d(BOR)}$ after $V_{CC} = V_{(B_IT-)} + V_{hys(B_IT-)}$. The default FLL+ settings must not be changed until $V_{CC} \geq V_{CC(min)}$, where $V_{CC(min)}$ is the minimum supply voltage for the desired operating frequency. See the *MSP430x4xx Family User's Guide* (SLAU056) for more information on the brownout and SVS circuit.

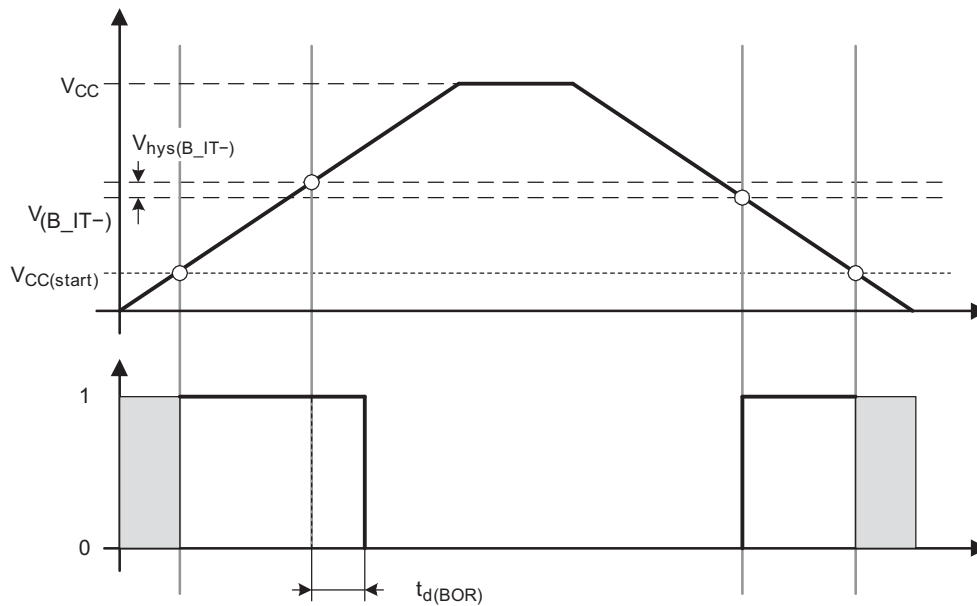


Figure 10. POR and BOR vs Supply Voltage

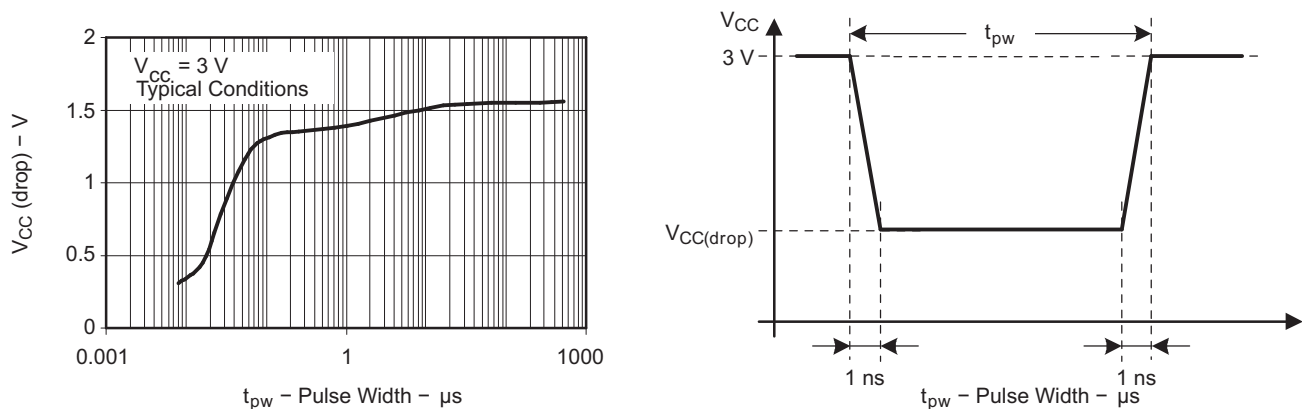


Figure 11. $V_{CC(drop)}$ Level with a Square Voltage Drop to Generate a POR/Brownout Signal

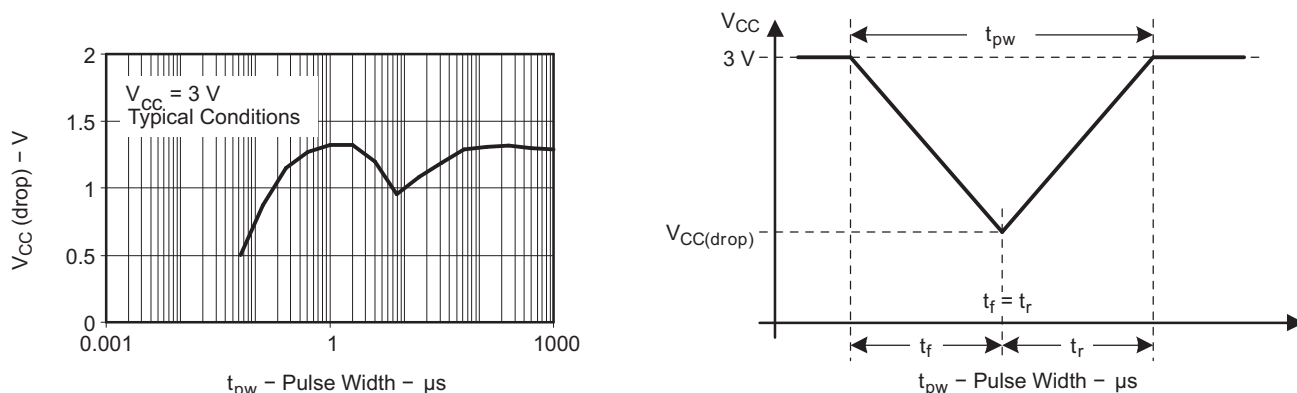


Figure 12. $V_{CC(drop)}$ Level With a Triangle Voltage Drop to Generate a POR or BOR Signal

SVS (Supply Voltage Supervisor and Monitor)⁽¹⁾⁽²⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|----------------------------|--|---------------|-------------------------------|--------------------|------------------------------|---------------|
| $t_{(SVSR)}$ | $dV_{CC}/dt > 30 \text{ V/ms}$ (see Figure 13) | | 5 | | 150 | μs |
| | $dV_{CC}/dt \leq 30 \text{ V/ms}$ | | | | 2000 | |
| $t_{d(SV\text{Son})}$ | SVSon, switch from VLD = 0 to VLD \neq 0, $V_{CC} = 3 \text{ V}$ | | 20 | | 150 | μs |
| t_{settle} | VLD \neq 0 ⁽³⁾ | | | | 12 | μs |
| $V_{(SVS\text{start})}$ | VLD \neq 0, $V_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 13) | | | 1.55 | 1.7 | V |
| $V_{\text{hys}(SVS_IT-)}$ | $V_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 13) | VLD = 1 | 70 | 120 | 155 | mV |
| | | VLD = 2 to 14 | $V_{(SVS_IT-)} \times 0.004$ | | $V_{(SVS_IT-)} \times 0.08$ | |
| | $V_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 13), external voltage applied on A7 | | VLD = 15 | 4.4 | 10.4 | mV |
| $V_{(SVS_IT-)}$ | $V_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 13) | VLD = 1 | 1.8 | 1.9 | 2.05 | V |
| | | VLD = 2 | 1.94 | 2.1 | 2.25 | |
| | | VLD = 3 | 2.05 | 2.2 | 2.37 | |
| | | VLD = 4 | 2.14 | 2.3 | 2.48 | |
| | | VLD = 5 | 2.24 | 2.4 | 2.6 | |
| | | VLD = 6 | 2.33 | 2.5 | 2.71 | |
| | | VLD = 7 | 2.46 | 2.65 | 2.86 | |
| | | VLD = 8 | 2.58 | 2.8 | 3 | |
| | | VLD = 9 | 2.69 | 2.9 | 3.13 | |
| | | VLD = 10 | 2.83 | 3.05 | 3.29 | |
| | | VLD = 11 | 2.94 | 3.2 | 3.42 | |
| | | VLD = 12 | 3.11 | 3.35 | 3.61 ⁽⁴⁾ | |
| | | VLD = 13 | 3.24 | 3.5 | 3.76 ⁽⁴⁾ | |
| | | VLD = 14 | 3.43 | 3.7 ⁽⁴⁾ | 3.99 ⁽⁴⁾ | |
| | $V_{CC}/dt \leq 3 \text{ V/s}$ (see Figure 13), external voltage applied on A7 | | VLD = 15 | 1.1 | 1.2 | 1.3 |
| $I_{CC(SVS)}^{(5)}$ | VLD \neq 0, $V_{CC} = 2.2 \text{ V}, 3 \text{ V}$ | | | 10 | 15 | μA |

(1) The current consumption of the SVS module is not included in the I_{CC} current consumption data.

(2) The SVS is not active at power up.

(3) t_{settle} is the settling time that the comparator o/p needs to have a stable level after VLD is switched from VLD \neq 0 to a different VLD value between 2 and 15. The overdrive is assumed to be $> 50 \text{ mV}$.

(4) The recommended operating voltage range is limited to 3.6 V.

(5) The current consumption of the SVS module is not included in the I_{CC} current consumption data.

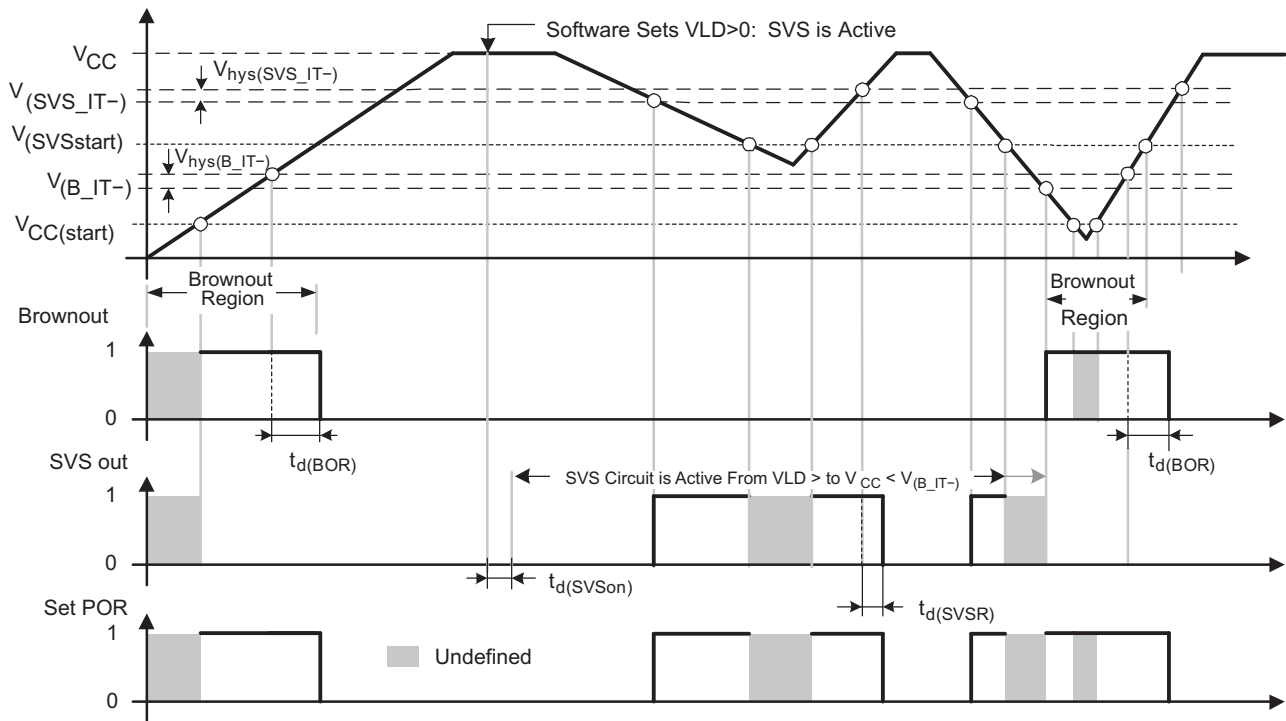


Figure 13. SVS Reset (SVSR) vs Supply Voltage

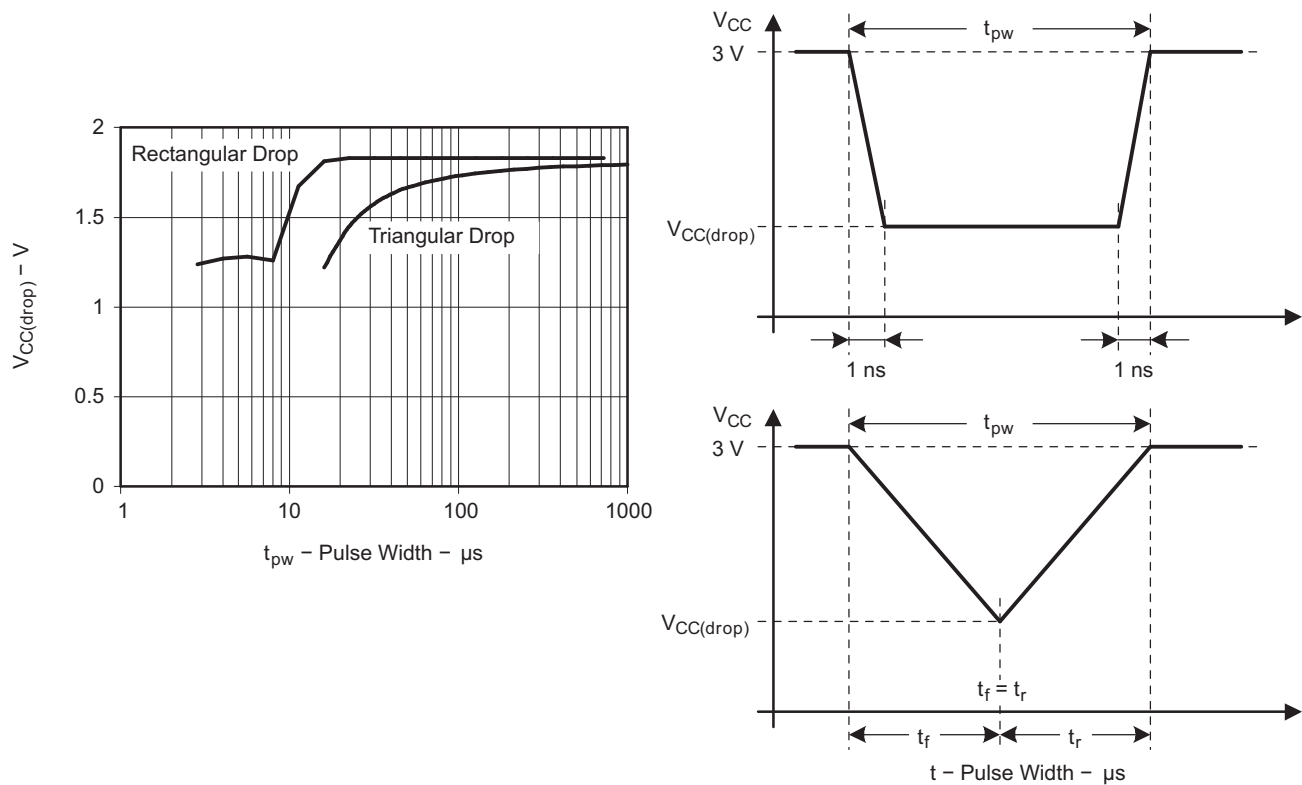


Figure 14. $V_{CC(drop)}$ with a Square Voltage Drop and a Triangle Voltage Drop to Generate an SVS Signal

DCO

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-------------------------|--|-----------------|------|------|------|------|
| f _(DCOCLK) | N _(DCO) = 01Eh, FN ₈ = FN ₄ = FN ₃ = FN ₂ = 0, D = 2, DCOPLUS = 0, f _{Crystal} = 32.768 kHz | 2.2 V, 3 V | | 1 | | MHz |
| f _(DCO = 2) | FN ₈ = FN ₄ = FN ₃ = FN ₂ = 0, DCOPLUS = 1 | 2.2 V | 0.3 | 0.65 | 1.25 | MHz |
| | | 3 V | 0.3 | 0.7 | 1.3 | |
| f _(DCO = 27) | FN ₈ = FN ₄ = FN ₃ = FN ₂ = 0, DCOPLUS = 1 | 2.2 V | 2.5 | 5.6 | 10.5 | MHz |
| | | 3 V | 2.7 | 6.1 | 11.3 | |
| f _(DCO = 2) | FN ₈ = FN ₄ = FN ₃ = FN ₂ = 1, DCOPLUS = 1 | 2.2 V | 0.7 | 1.3 | 2.3 | MHz |
| | | 3 V | 0.8 | 1.5 | 2.5 | |
| f _(DCO = 27) | FN ₈ = FN ₄ = FN ₃ = FN ₂ = 1, DCOPLUS = 1 | 2.2 V | 5.7 | 10.8 | 18 | MHz |
| | | 3 V | 6.5 | 12.1 | 20 | |
| f _(DCO = 2) | FN ₈ = FN ₄ = 0, FN ₃ = 1, FN ₂ = x, DCOPLUS = 1 | 2.2 V | 1.2 | 2 | 3 | MHz |
| | | 3 V | 1.3 | 2.2 | 3.5 | |
| f _(DCO = 27) | FN ₈ = FN ₄ = 0, FN ₃ = 1, FN ₂ = x, DCOPLUS = 1 | 2.2 V | 9 | 15.5 | 25 | MHz |
| | | 3 V | 10.3 | 17.9 | 28.5 | |
| f _(DCO = 2) | FN ₈ = 0, FN ₄ = 1, FN ₃ = FN ₂ = x, DCOPLUS = 1 | 2.2 V | 1.8 | 2.8 | 4.2 | MHz |
| | | 3 V | 2.1 | 3.4 | 5.2 | |
| f _(DCO = 27) | FN ₈ = 0, FN ₄ = 1, FN ₃ = FN ₂ = x, DCOPLUS = 1 | 2.2 V | 13.5 | 21.5 | 33 | MHz |
| | | 3 V | 16 | 26.6 | 41 | |
| f _(DCO = 2) | FN ₈ = 1, FN ₄ = 1 = FN ₃ = FN ₂ = x, DCOPLUS = 1 | 2.2 V | 2.8 | 4.2 | 6.2 | MHz |
| | | 3 V | 4.2 | 6.3 | 9.2 | |
| f _(DCO = 27) | FN ₈ = 1, FN ₄ = 1 = FN ₃ = FN ₂ = x, DCOPLUS = 1 | 2.2 V | 21 | 32 | 46 | MHz |
| | | 3 V | 30 | 46 | 70 | |
| S _n | Step size between adjacent DCO taps: S _n = f _{DCO(Tap n+1)} / f _{DCO(Tap n)} (see Figure 16 for taps 21 to 27) | 1 < TAP ≤ 20 | 1.06 | | 1.11 | |
| | | TAP = 27 | 1.07 | | 1.17 | |
| D _t | Temperature drift, N _(DCO) = 01Eh, FN ₈ = FN ₄ = FN ₃ = FN ₂ = 0, D = 2, DCOPLUS = 0 | 2.2 V | -0.2 | -0.3 | -0.4 | %/°C |
| | | 3 V | -0.2 | -0.3 | -0.4 | |
| D _V | Drift with V _{CC} variation, N _(DCO) = 01Eh, FN ₈ = FN ₄ = FN ₃ = FN ₂ = 0, D = 2, DCOPLUS = 0 | 2.2 V, 3 V | 0 | 5 | 15 | %/V |

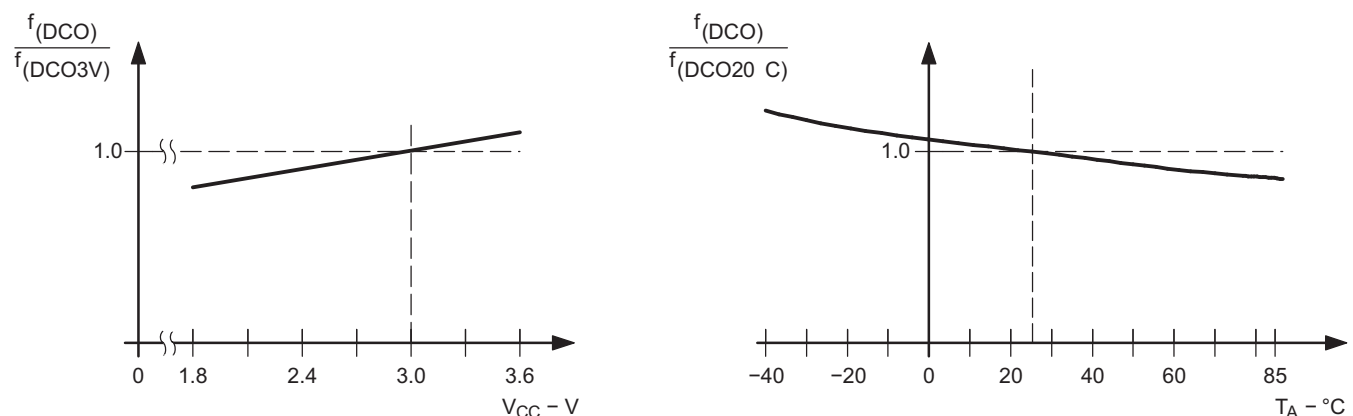


Figure 15. DCO Frequency vs Supply Voltage V_{CC} and vs Ambient Temperature

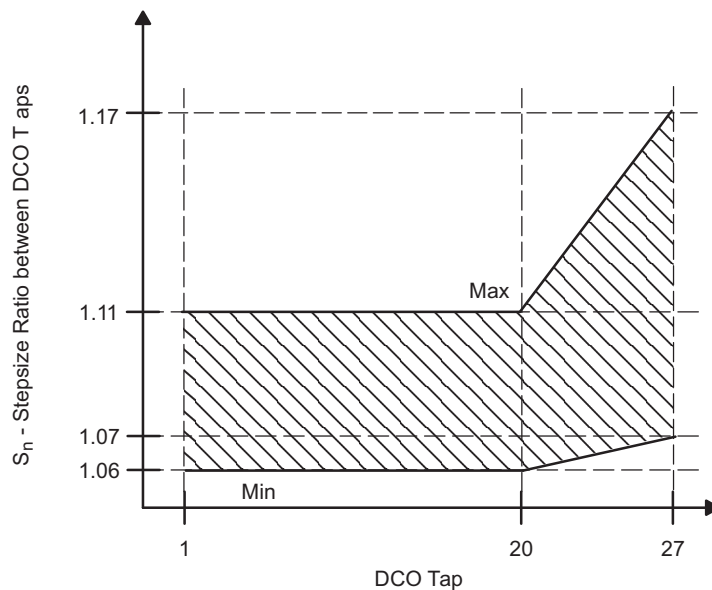


Figure 16. DCO Tap Step Size

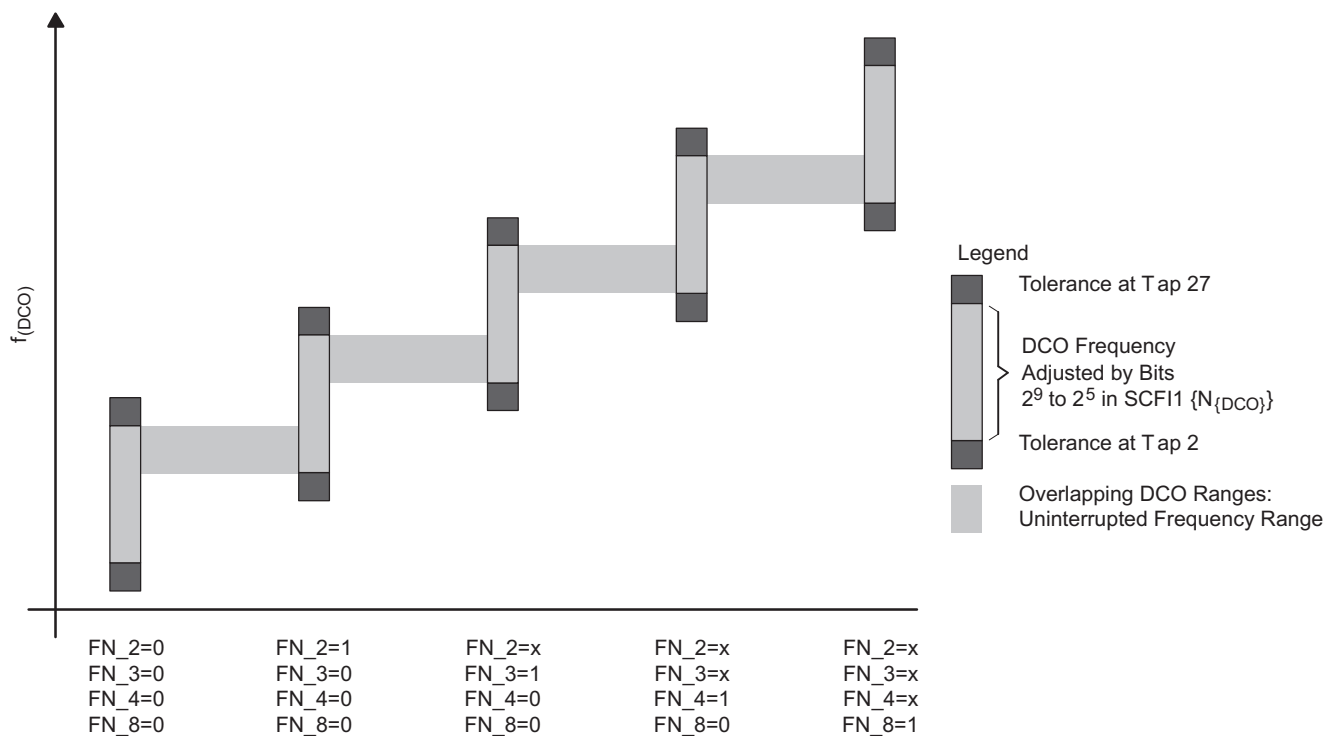


Figure 17. Five Overlapping DCO Ranges Controlled by FN_x Bits

Crystal Oscillator, LFXT1 Oscillator⁽¹⁾ (2)

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-------------------|--|-----------------|-----------------|-----------------------|-----|-----------------------|------|
| C _{XIN} | Integrated input capacitance ⁽³⁾ | OSCCAPx = 0h | 2.2 V, 3 V | | 0 | | pF |
| | | OSCCAPx = 1h | | | 10 | | |
| | | OSCCAPx = 2h | | | 14 | | |
| | | OSCCAPx = 3h | | | 18 | | |
| C _{XOUT} | Integrated output capacitance ⁽³⁾ | OSCCAPx = 0h | 2.2 V, 3 V | | 0 | | pF |
| | | OSCCAPx = 1h | | | 10 | | |
| | | OSCCAPx = 2h | | | 14 | | |
| | | OSCCAPx = 3h | | | 18 | | |
| V _{IL} | Input levels at XIN ⁽⁴⁾ | | 2.2 V, 3 V | V _{SS} | | 0.2 × V _{CC} | V |
| V _{IH} | | | | 0.8 × V _{CC} | | V _{CC} | |

- (1) The parasitic capacitance from the package and board may be estimated to be 2 pF. The effective load capacitor for the crystal is $(C_{XIN} \times C_{XOUT}) / (C_{XIN} + C_{XOUT})$. This is independent of XTS_FLL.
- (2) To improve EMI on the low-power LFXT1 oscillator, particularly in the LF mode (32 kHz), the following guidelines should be observed.
 - (a) Keep the trace between the device and the crystal as short as possible.
 - (b) Design a good ground plane around the oscillator pins.
 - (c) Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
 - (d) Avoid running PCB traces underneath or adjacent to the XIN and XOUT pins.
 - (e) Use assembly materials and techniques that avoid any parasitic load on the oscillator XIN and XOUT pins.
 - (f) If conformal coating is used, ensure that it does not induce capacitive or resistive leakage between the oscillator pins.
 - (g) Do not route the XOUT line to the JTAG header to support the serial programming adapter as shown in other documentation. This signal is no longer required for the serial programming adapter.
- (3) External capacitance is recommended for precision real-time clock applications; OSCCAPx = 0h.
- (4) Applies only when using an external logic-level clock source. XTS_FLL must be set. Not applicable when using a crystal or resonator.

Scan IF, Port Drive, Port Timing

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-----------------|-----|-----|-----|------|
| V _{OL} (SIFCHx) | Voltage drop due to excitation transistor's on-resistance (see Figure 18) I(SIFCHx) = 2 mA, SIFTEN = 1 | 3 V | | | 0.3 | V |
| V _{OH} (SIFCHx) | Voltage drop due to damping transistor's on-resistance ⁽¹⁾ (see Figure 18) I(SIFCHx) = -200 µA, SIFTEN = 1 | 3 V | | | 0.1 | V |
| V _{OL} (SIFCOM) | I(SIFCOM) = 3 mA, SIFSH = 1 | 2.2 V, 3 V | 0 | | 0.1 | V |
| I _{SIFCHx} (tri-state) | V(SIFCHx) = 0 V to AV _{CC} , port function disabled, SIFSH = 1 | 3 V | -50 | | 50 | nA |
| Δt _{dSIFCH} : t _{wEx} (tsm) - t _{wSIFCH} | Change of pulse duration of internal signal SIFEX(tsm) to pulse duration at pin SIFCHx (see Figure 18) I(SIFCHx) = 3 mA, t _{Ex} (SIFCHx) = 500 ns ±20% | 2.2 V, 3 V | -20 | | 20 | ns |

(1) SIFCOM = 1.5V , supplied externally (see Figure 19)

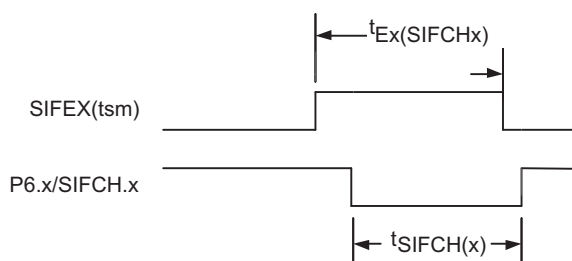


Figure 18. P6.x/SIFCHx Timing, SIFCHx Function Selected

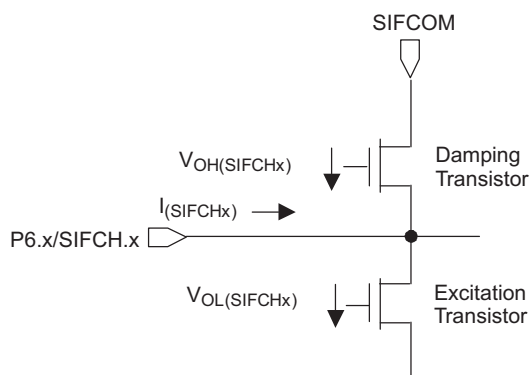


Figure 19. Voltage Drop Due to On-Resistance

Scan IF, Sample Capacitor/Ri Timing⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--------------------------|---|-----------------------------|-----------------|-----|-----|-----|------|
| C _{SHC(SIFCHx)} | Sample capacitance at SIFCHx pin | SIFEx(tsm) = 1, SIFSH = 1 | 2.2 V, 3 V | | 5 | 7 | pF |
| R _{i(SIFCHx)} | Serial input resistance at the SIFCHx pin | SIFEx(tsm) = 1, SIFSH = 1 | 2.2 V, 3 V | | 1.5 | 3 | kΩ |
| t _{Hold} | Maximum hold time ⁽²⁾ | ΔV _{sample} < 3 mV | | 62 | | | μs |

- (1) The minimum sampling time (7.6 x tau for 1/2 LSB accuracy) with maximum C_{SHC(SIFCHx)} and R_{i(SIFCHx)} and R_{i(source)} is t_{sample(min)} ~ 7.6 x C_{SHC(SIFCHx)} x (R_{i(SIFCHx)} + R_{i(source)}) with R_{i(source)} estimated at 3 kΩ, t_{sample(min)} = 319 ns.
- (2) The sampled voltage at the sample capacitance varies less than 3 mV (ΔV_{sample}) during the hold time t_{Hold}. If the voltage is sampled after t_{Hold}, the sampled voltage may be any other value.

Scan IF, $V_{CC}/2$ Generator

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V_{CC} | MIN | TYP | MAX | UNIT |
|-------------------------|---|--|------------|--------------------|--------------------|---------|
| AV_{CC} | Analog supply voltage | $AV_{CC} = DV_{CC}$ (connected together), $AV_{SS} = DV_{SS}$ (connected together) | 2.2 | | 3.6 | V |
| AI_{CC} | Scan IF $V_{CC}/2$ generator operating supply current into AV_{CC} terminal | 2.2 V | | 250 | 350 | nA |
| | | 3 V | | 370 | 450 | |
| $f_{refresh}(SIFCOM)$ | $V_{CC}/2$ refresh frequency | Source clock = ACLK | 2.2 V, 3 V | 30 | 32.768 | kHz |
| $V_{(SIFCOM)}$ | Output voltage at pin SIFCOM | C_L at SIFCOM pin = 470 nF $\pm 20\%$, $I_{Load} = 1 \mu A$ | | $AV_{CC}/2 - 0.05$ | $AV_{CC}/2 + 0.05$ | V |
| $I_{source}(SIFCOM)$ | SIFCOM source current ⁽¹⁾ (see Figure 20) | 2.2 V | -500 | | | μA |
| | | 3 V | -900 | | | |
| $I_{sink}(SIFCOM)$ | SIFCOM sink current | 2.2 V | 150 | | | nA |
| | | 3 V | 180 | | | |
| $t_{recovery}(SIFCOM)$ | Time to recover from voltage drop on load | $I_{Load1} = I_{Load3} = 0$ mA, $I_{Load2} = 3$ mA, $t_{load(on)} = 500$ ns, C_L at SIFCOM pin = 470 nF $\pm 20\%$ | 2.2 V, 3 V | | 30 | μs |
| $t_{on}(SIFCOM)$ | Time to reach 98% after $V_{CC}/2$ is switched on | C_L at SIFCOM pin = 470 nF $\pm 20\%$, $f_{refresh}(SIFCOM) = 32768$ Hz | 2.2 V, 3 V | 1.7 | 6 | ms |
| $t_{VccSettle}(SIFCOM)$ | Settling time to $\pm V_{CC}/512$ (2 LSB) after AV_{CC} voltage change | SIFEN = 1, SIFVCC2 = 1, SIFSH = 0, $AV_{CC} = AV_{CC} - 100$ mV, $f_{refresh}(SIFCOM) = 32768$ Hz | 2.2 V, 3 V | 80 | | ms |
| | | $AV_{CC} = AV_{CC} + 100$ mV, $f_{refresh}(SIFCOM) = 32768$ Hz | 2.2 V, 3 V | 3 | | |

- (1) The sink and source currents are a function of the voltage at the pin SIFCOM. The maximum currents are reached if SIFCOM is shorted to GND or V_{CC} . Due to the topology of the output section (see Figure 20) the $V_{CC}/2$ generator can source relatively large currents but can sink only small currents.

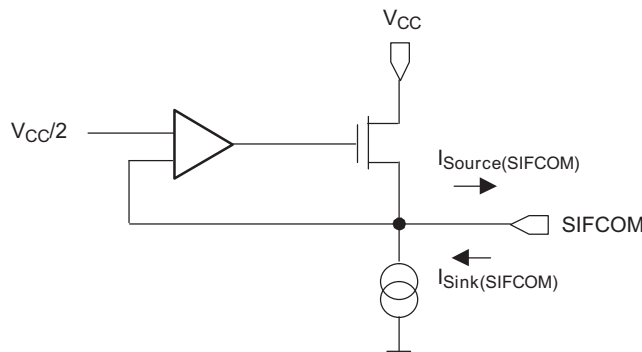


Figure 20. P6.x/SIFCHx Timing, SIFCHx Function Selected

Scan IF, 10-bit DAC

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|------------------------------|--|--|------------|-----|-----|------|
| AV _{CC} | Analog supply voltage | AV _{CC} = DV _{CC} (connected together) AV _{SS} = DV _{SS} (connected together) | 2.2 | | 3.6 | V |
| AI _{CC} | Scan IF 10-bit DAC operating supply current into AV _{CC} terminal | C _L at SIFCOM pin = 470 nF ±20%, f _{refresh} (SIFCOM) = 32768 Hz | 2.2 V | 23 | 45 | μA |
| | | | 3 V | 33 | 60 | |
| | Resolution | | | 10 | | bit |
| INL | Integral nonlinearity | R _L = 1000 MΩ, C _L = 20 pF | 2.2 V, 3 V | ±2 | ±5 | LSB |
| DNL | Differential nonlinearity | R _L = 1000 MΩ, C _L = 20 pF | 2.2 V, 3 V | | ±1 | LSB |
| E _{ZS} | Zero scale error | | 2.2 V, 3 V | | ±10 | mV |
| E _G | Gain error | | 2.2 V, 3 V | | 0.6 | % |
| R _O | Output resistance | | | 25 | 50 | kΩ |
| t _{on} (SIFDAC) | On time after AV _{CC} of SIFDAC is switched on | V _{+SIFCA} - V _{SIFDAC} = ±6 mV | 2.2 V, 3 V | | 2 | μs |
| t _{Settle} (SIFDAC) | Settling time | SIFDAC code = 1C0h → 240h, V _{SIFDAC} (240h) - V _{+SIFCA} = +6 mV | 2.2 V, 3 V | | 2 | μs |
| | | SIFDAC code = 240h → 1C0h, V _{SIFDAC} (1C0h) - V _{+SIFCA} = -6 mV | 2.2 V, 3 V | | 2 | |

Scan IF, Comparator

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|--|---|------------|------------------------|-----|-------|
| AV _{CC} | Analog supply voltage | AV _{CC} = DV _{CC} (connected together), AV _{SS} = DV _{SS} (connected together) | 2.2 | | 3.6 | V |
| AI _{CC} | Scan IF comparator operating supply current into AV _{CC} terminal | 2.2 V | | 25 | 35 | μA |
| | | 3 V | | 35 | 50 | |
| V _{IC} | Common mode input voltage range ⁽¹⁾ | 2.2 V, 3 V | 0.9 | AV _{CC} - 0.6 | | V |
| V _{Offset} | Input offset voltage | 2.2 V, 3 V | | | ±30 | mV |
| dV _{Offset} /dT | Temperature coefficient of V _{Offset} | 2.2 V, 3 V | | 10 | | μV/°C |
| dV _{Offset} /dV _{CC} | V _{Offset} supply voltage (V _{CC}) sensitivity | 2.2 V, 3 V | | 0.3 | | mV/V |
| V _{hys} | Input voltage hysteresis | V _{+terminal} = V _{-terminal} = 0.5 x V _{CC} | 2.2 V | 0 | 18 | mV |
| | | | 3 V | 0 | 18 | |
| t _{on} (SIFCA) | On time after SIFCA is switched on | V _{+SIFCA} - V _{SIFDAC} = +6 mV, V _{+SIFCA} = 0.5 x AV _{CC} | 2.2 V, 3 V | | 2 | μs |
| t _{Settle} (SIFCA) | Settle time | V _{+SIFCA} - V _{SIFDAC} = -12 mV → 6 mV, V _{+SIFCA} = 0.5 x AV _{CC} | 2.2 V, 3 V | | 2.0 | μs |

(1) The comparator output is reliable when at least one of the input signals is within the common mode input voltage range.

Scan IF, SIFCLK Oscillator

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | V _{CC} | MIN | TYP | MAX | UNIT |
|---------------------------|--|---|------------|-----------------|------|------|------|-------|
| AV _{CC} | Analog supply voltage | AV _{CC} = DV _{CC} (connected together), AV _{SS} = DV _{SS} (connected together) | | | 2.2 | | 3.6 | V |
| AI _{CC} | Scan IF oscillator operating supply current into AV _{CC} terminal | | | 2.2 V | | | 75 | μA |
| | | | | 3 V | | | 90 | |
| f _{SIFCLKG} = 0 | Scan IF oscillator at minimum setting | T _A = 25°C, SIFCLKFQ = 0000 | SIFNOM = 0 | | 1.8 | | 3.2 | MHz |
| | | | SIFNOM = 1 | | 0.45 | | 0.8 | |
| f _{SIFCLKG} = 8 | Scan IF oscillator at nominal setting | T _A = 25°C, SIFCLKFQ = 0000 | SIFNOM = 0 | | | 4 | | MHz |
| | | | SIFNOM = 1 | | | 1 | | |
| f _{SIFCLKG} = 15 | Scan IF oscillator at maximum setting | T _A = 25°C, SIFCLKFQ = 0000 | SIFNOM = 0 | | 4.48 | | 6.8 | MHz |
| | | | SIFNOM = 1 | | 1.12 | | 1.7 | |
| t _{on} (SIFCLKG) | Settling time to full operation after V _{CC} is switched on | | | 2.2 V, 3 V | 150 | | 500 | ns |
| S _(SIFCLK) | Frequency change per ±1 SIFCLKFQ(SIFCTL5) step | S _(SIFCLK) = f _(SIFCLKFQ + 1) / f _(SIFCLKFQ) | | 2.2 V, 3 V | 1.01 | 1.05 | 1.18 | Hz/Hz |
| D _t | Temperature Coefficient | SIFCLKFQ _(SIFCTL5) = 8 | | 2.2 V, 3 V | | | 0.35 | %/_C |
| D _V | Frequency vs supply voltage V _{CC} variation | SIFCLKFQ _(SIFCTL5) = 8 | | 2.2 V, 3 V | | | 2 | %/V |

Flash Memory

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-----------------------------|---|-----------------------|-----------------|-----------------|-----|------------------|
| V _{CC} (PGM/ERASE) | Program and erase supply voltage | | 2.7 | | 3.6 | V |
| f _{FTG} | Flash timing generator frequency | | 257 | | 476 | kHz |
| I _{PGM} | Supply current from DV _{CC} during program | 2.7 V, 3.6 V | | 3 | 5 | mA |
| I _{ERASE} | Supply current from DV _{CC} during erase | 2.7 V, 3.6 V | | 3 | 7 | mA |
| t _{CPT} | Cumulative program time | (1) | 2.7 V, 3.6 V | | 10 | ms |
| t _{CMErase} | Cumulative mass erase time | (2) | 2.7 V, 3.6 V | 20 | | ms |
| | Program and erase endurance | | 10 ⁴ | 10 ⁵ | | cycles |
| t _{Retention} | Data retention duration | T _J = 25°C | 100 | | | years |
| t _{Word} | Word or byte program time | (3) | | 35 | | t _{FTG} |
| t _{Block, 0} | Block program time for 1st byte or word | | | 30 | | |
| t _{Block, 1-63} | Block program time for each additional byte or word | | | 21 | | |
| t _{Block, End} | Block program end-sequence wait time | | | 6 | | |
| t _{Mass Erase} | Mass erase time | | | 5297 | | |
| t _{Seg Erase} | Segment erase time | | | 4819 | | |

- (1) The cumulative program time must not be exceeded when writing to a 64-byte flash block. This parameter applies to all programming methods: individual word/byte write and block write modes.
- (2) The mass erase duration generated by the flash timing generator is at least 11.1 ms (= 5297 × (1 / f_{FTG,max}) = 5297 × (1 / 476 kHz)). To achieve the required cumulative mass erase time, the Flash Controller's mass erase operation can be repeated until this time is met. (A worst case minimum of 19 cycles are required).
- (3) These values are hardwired into the Flash Controller's state machine (t_{FTG} = 1/f_{FTG}).

JTAG Interface

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-----------------------|--|-----------------|-----------------|-----|-----|-----|------|
| f _{TCK} | TCK input frequency | (1) | 2.2 V | 0 | | 5 | MHz |
| | | | 3V | 0 | | 10 | MHz |
| R _{Internal} | Internal pullup resistance on TMS, TCK, TDI/TCLK | (2) | 2.2 V, 3 V | 25 | 60 | 90 | kΩ |

(1) f_{TCK} may be restricted to meet the timing requirements of the module selected.

(2) TMS, TDI/TCLK, and TCK pullup resistors are implemented in all versions.

JTAG Fuse⁽¹⁾

over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---------------------|---|-----------------------|-----------------|-----|-----|-----|------|
| V _{CC(FB)} | Supply voltage during fuse-blow condition | T _A = 25°C | | 2.5 | | | V |
| V _{FB} | Voltage level on TDI/TCLK for fuse-blow: | | | 6 | | 7 | V |
| I _{FB} | Supply current into TDI/TCLK during fuse blow | | | | | 100 | mA |
| t _{FB} | Time to blow fuse | | | | | 1 | ms |

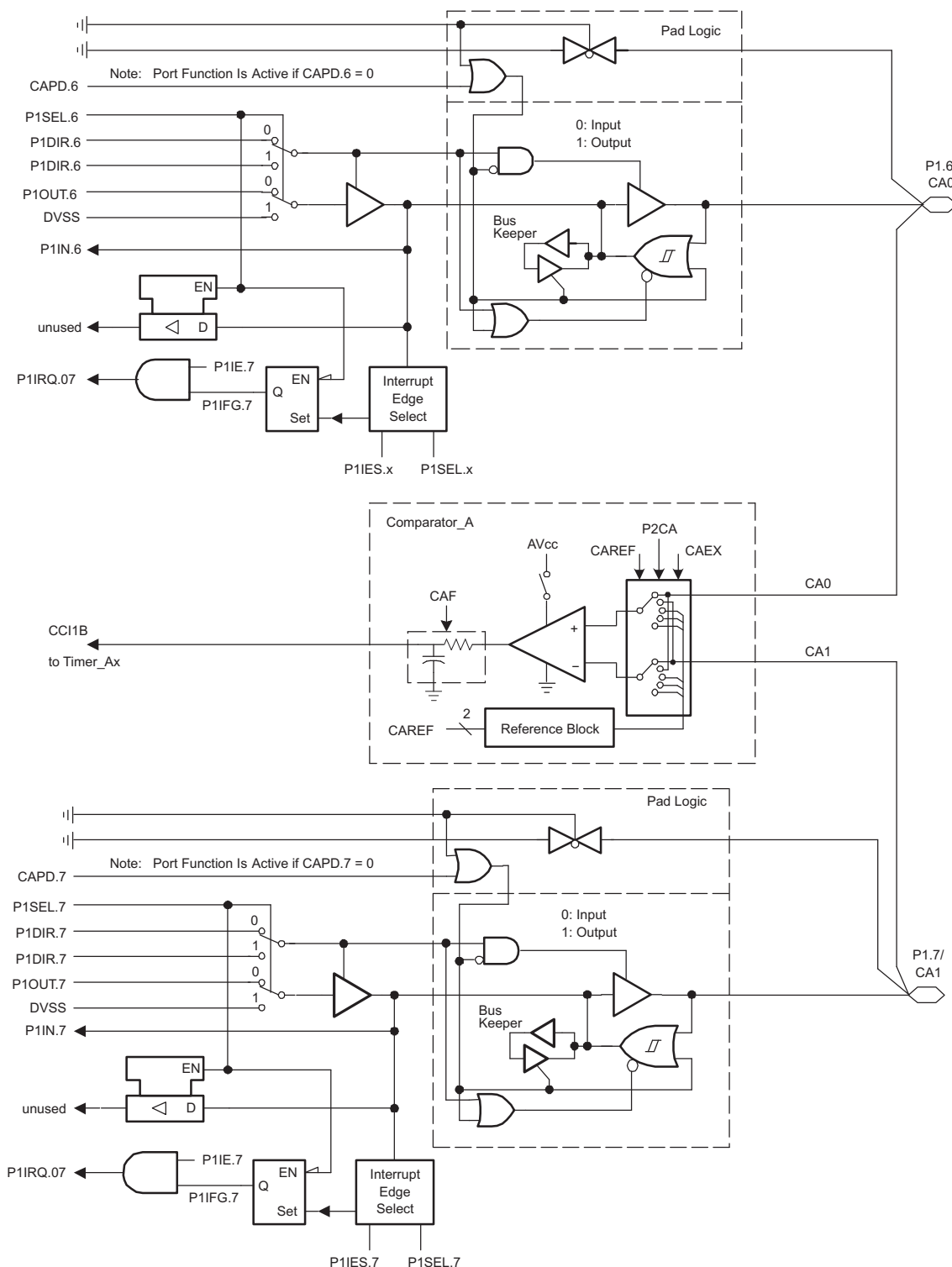
(1) After the fuse is blown, no further access to the MSP430 JTAG/Test and emulation features is possible. The JTAG block is switched to bypass mode.

Port P1, P1.0 to P1.5, Input/Output With Schmitt Trigger

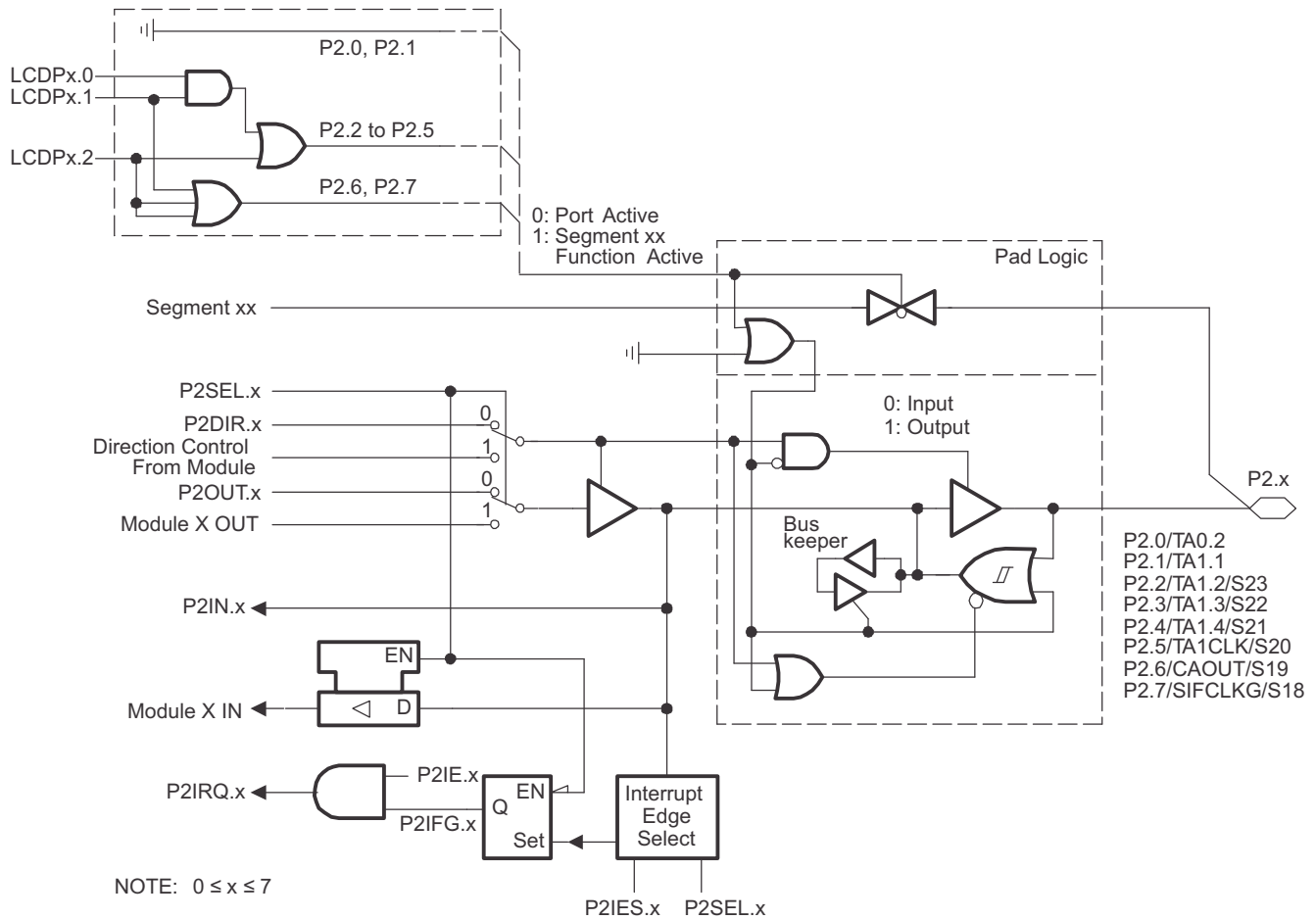


‡ Timer1 A

Port P1, P1.6, P1.7 Input/Output With Schmitt Trigger



Port P2, P2.0 to P2.7, Input/Output With Schmitt Trigger



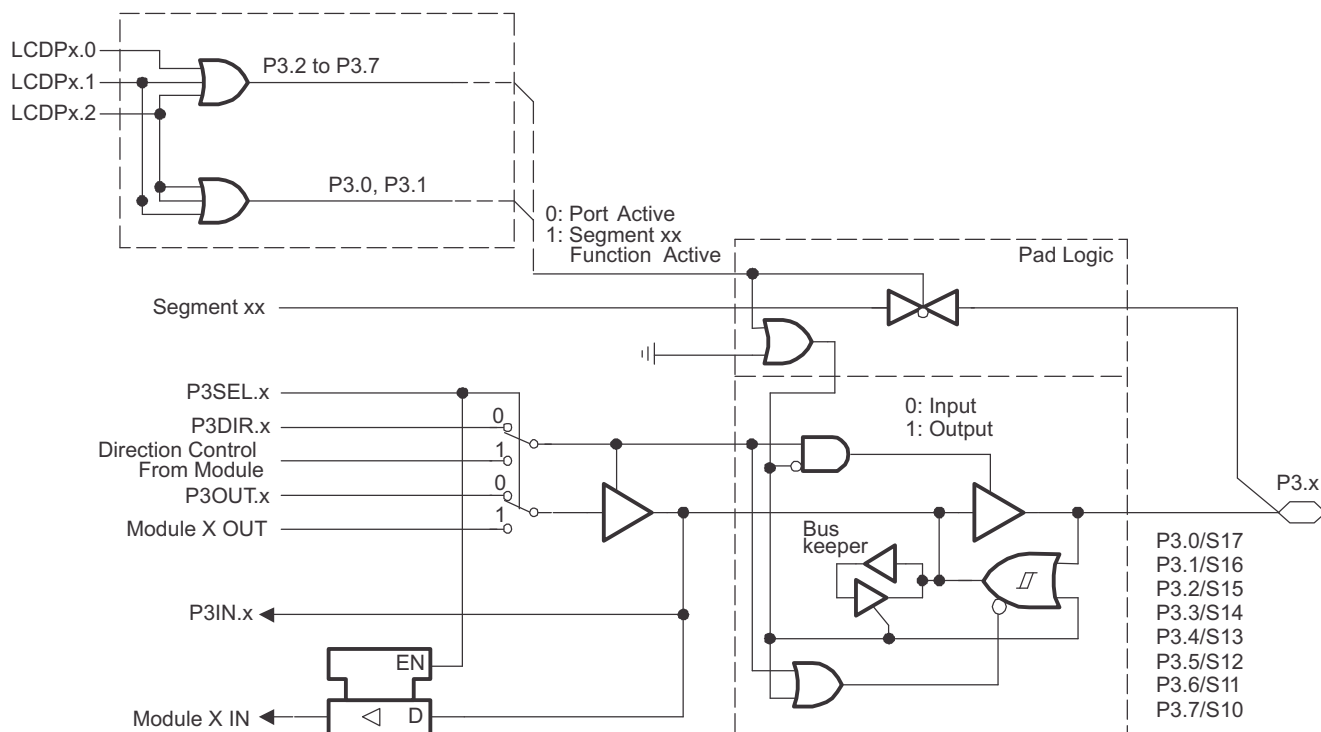
| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN | PnIE.x | PnIFG.x | PnIES.x |
|---------|---------|-------------------------------|---------|------------------------|--------|----------------------|--------|---------|---------|
| P2SEL.0 | P2DIR.0 | P2DIR.0 | P2OUT.0 | Out2 Sig. [†] | P2IN.0 | CCI2A [†] | P2IE.0 | P2IFG.0 | P2IES.0 |
| P2SEL.1 | P2DIR.1 | P2DIR.1 | P2OUT.1 | Out1 Sig. [‡] | P2IN.1 | CCI1A [‡] | P2IE.1 | P2IFG.1 | P2IES.1 |
| P2SEL.2 | P2DIR.2 | P2DIR.2 | P2OUT.2 | Out2 Sig. [‡] | P2IN.2 | CCI2A [‡] | P2IE.2 | P2IFG.2 | P2IES.2 |
| P2SEL.3 | P2DIR.3 | P2DIR.3 | P2OUT.3 | Out3 Sig. [‡] | P2IN.3 | CCI3A [‡] | P2IE.3 | P2IFG.3 | P2IES.3 |
| P2SEL.4 | P2DIR.4 | P2DIR.4 | P2OUT.4 | Out4 Sig. [‡] | P2IN.4 | CCI4A [‡] | P2IE.4 | P2IFG.4 | P2IES.4 |
| P2SEL.5 | P2DIR.5 | P2DIR.5 | P2OUT.5 | DVSS | P2IN.5 | TA1CLK1 [‡] | P2IE.5 | P2IFG.5 | P2IES.5 |
| P2SEL.6 | P2DIR.6 | P2DIR.6 | P2OUT.6 | CAOUT | P2IN.6 | Unused | P2IE.6 | P2IFG.6 | P2IES.6 |
| P2SEL.7 | P2DIR.7 | P2DIR.7 | P2OUT.7 | SIFCLKG [§] | P2IN.7 | Unused | P2IE.7 | P2IFG.7 | P2IES.7 |

[†]Timer0_A

[‡]Timer1_A

[§]Scan IF

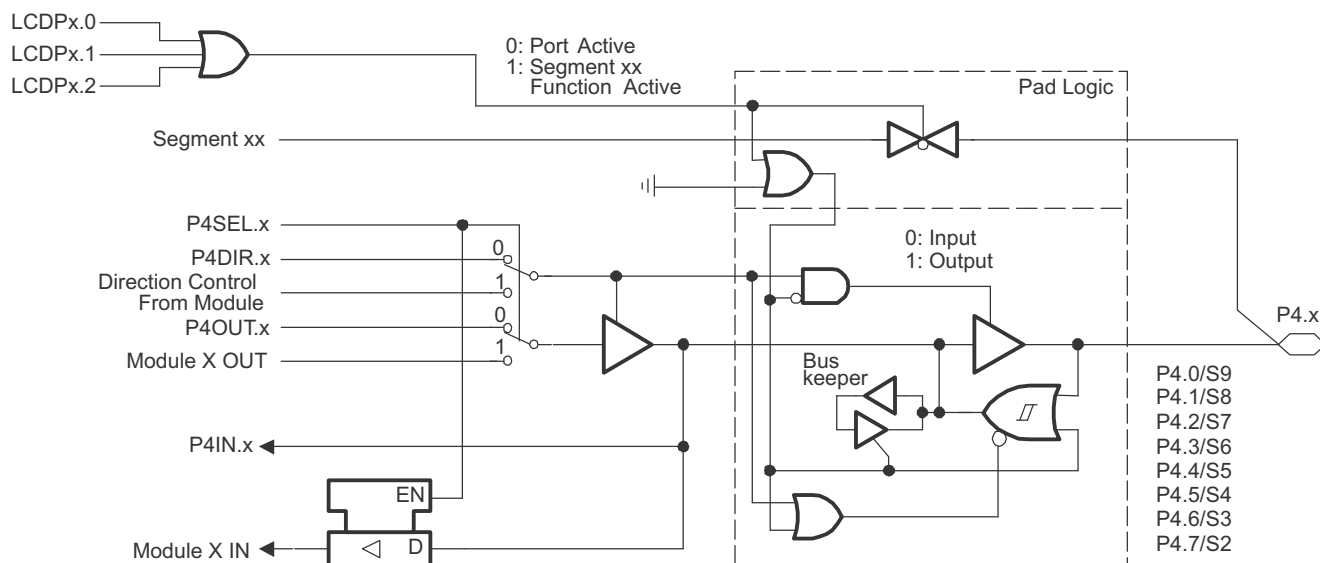
Port P3, P3.0 to P3.7, Input/Output With Schmitt Trigger



NOTE: $0 \leq x \leq 7$

| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN |
|---------|---------|-------------------------------|---------|--------------|--------|-------------|
| P3SEL.0 | P3DIR.0 | P3DIR.0 | P3OUT.0 | DVSS | P3IN.0 | Unused |
| P3SEL.1 | P3DIR.1 | P3DIR.1 | P3OUT.1 | DVSS | P3IN.1 | Unused |
| P3SEL.2 | P3DIR.2 | P3DIR.2 | P3OUT.2 | DVSS | P3IN.2 | Unused |
| P3SEL.3 | P3DIR.3 | P3DIR.3 | P3OUT.3 | DVSS | P3IN.3 | Unused |
| P3SEL.4 | P3DIR.4 | P3DIR.4 | P3OUT.4 | DVSS | P3IN.4 | Unused |
| P3SEL.5 | P3DIR.5 | P3DIR.5 | P3OUT.5 | DVSS | P3IN.5 | Unused |
| P3SEL.6 | P3DIR.6 | P3DIR.6 | P3OUT.6 | DVSS | P3IN.6 | Unused |
| P3SEL.7 | P3DIR.7 | P3DIR.7 | P3OUT.7 | DVSS | P3IN.7 | Unused |

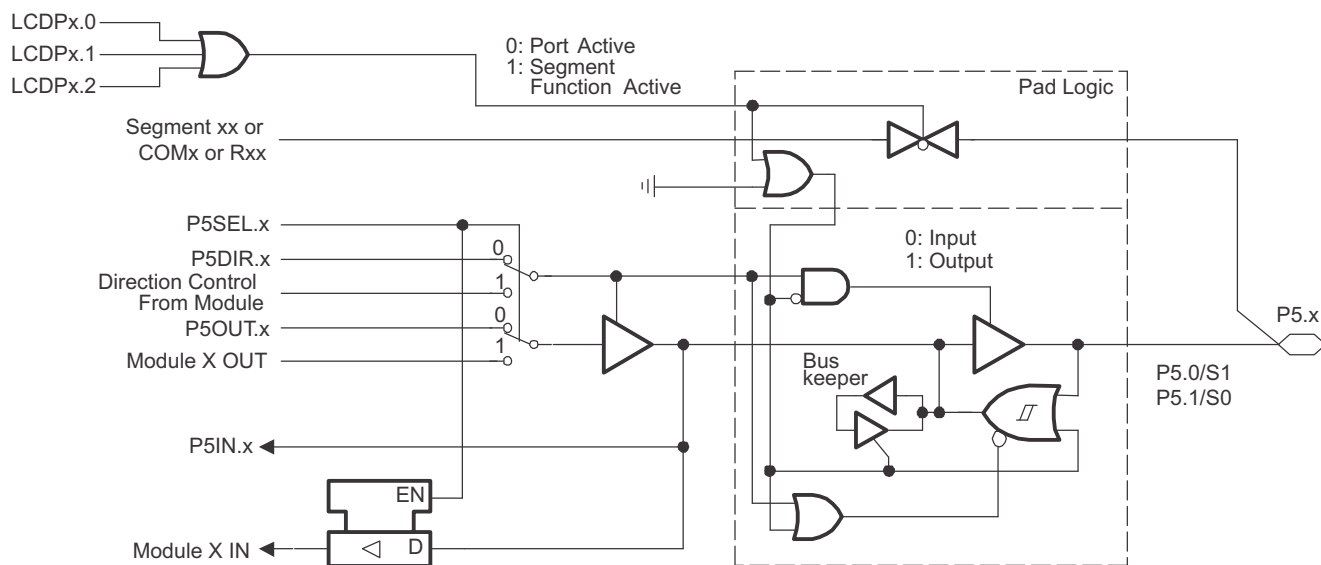
Port P4, P4.0 to P4.7, Input/Output With Schmitt Trigger



NOTE: $0 \leq x \leq 7$

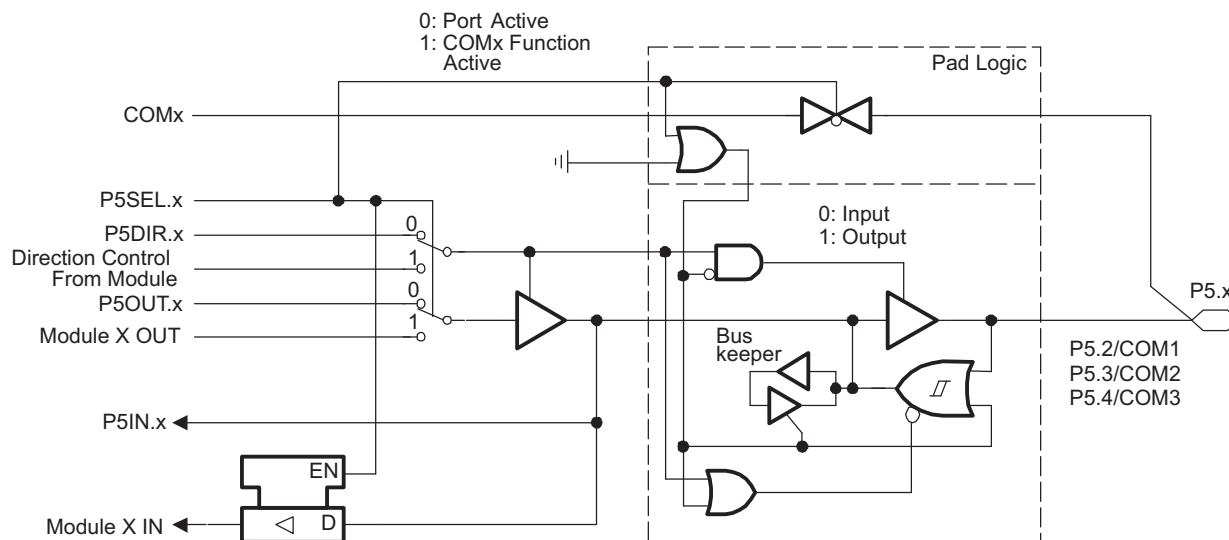
| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN |
|---------|---------|-------------------------------|---------|--------------|--------|-------------|
| P4SEL.0 | P4DIR.0 | P4DIR.0 | P4OUT.0 | DVSS | P4IN.0 | Unused |
| P4SEL.1 | P4DIR.1 | P4DIR.1 | P4OUT.1 | DVSS | P4IN.1 | Unused |
| P4SEL.2 | P4DIR.2 | P4DIR.2 | P4OUT.2 | DVSS | P4IN.2 | Unused |
| P4SEL.3 | P4DIR.3 | P4DIR.3 | P4OUT.3 | DVSS | P4IN.3 | Unused |
| P4SEL.4 | P4DIR.4 | P4DIR.4 | P4OUT.4 | DVSS | P4IN.4 | Unused |
| P4SEL.5 | P4DIR.5 | P4DIR.5 | P4OUT.5 | DVSS | P4IN.5 | Unused |
| P4SEL.6 | P4DIR.6 | P4DIR.6 | P4OUT.6 | DVSS | P4IN.6 | Unused |
| P4SEL.7 | P4DIR.7 | P4DIR.7 | P4OUT.7 | DVSS | P4IN.7 | Unused |

Port P5, P5.0, P5.1, Input/Output With Schmitt Trigger



| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN | Segment |
|---------|---------|-------------------------------|---------|--------------|--------|-------------|---------|
| P5SEL.0 | P5DIR.0 | P5DIR.0 | P5OUT.0 | DVSS | P5IN.0 | Unused | S1 |
| P5SEL.1 | P5DIR.1 | P5DIR.1 | P5OUT.1 | DVSS | P5IN.1 | Unused | S0 |

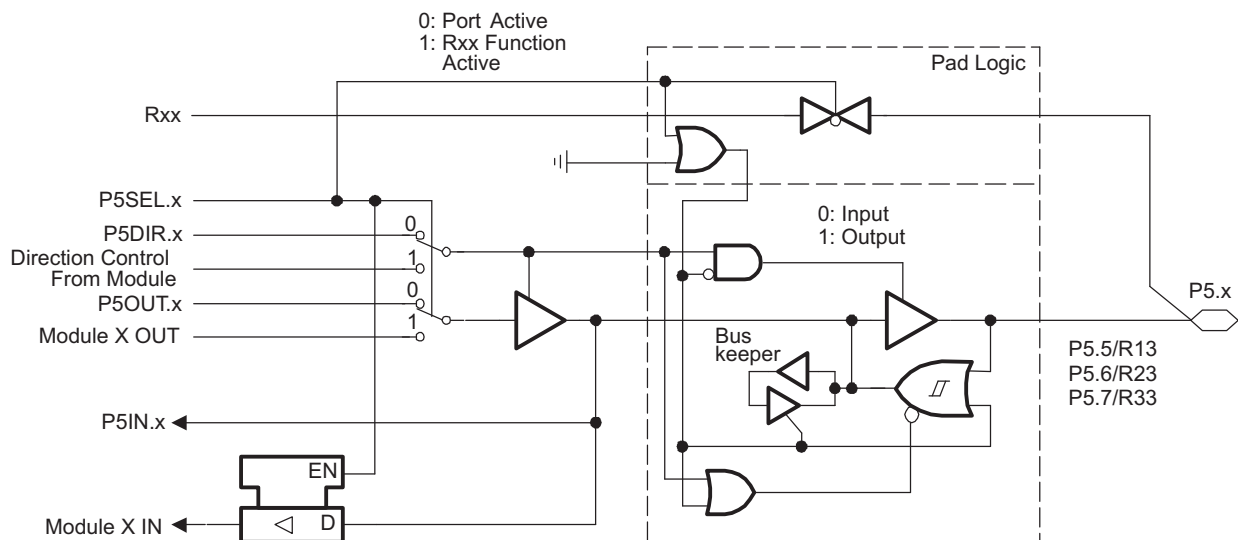
Port P5, P5.2 to P5.4, Input/Output With Schmitt Trigger



NOTE: $2 \leq x \leq 4$

| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN | COMx |
|---------|---------|-------------------------------|---------|--------------|--------|-------------|------|
| P5SEL.2 | P5DIR.2 | P5DIR.2 | P5OUT.2 | DVSS | P5IN.2 | Unused | COM1 |
| P5SEL.3 | P5DIR.3 | P5DIR.3 | P5OUT.3 | DVSS | P5IN.3 | Unused | COM2 |
| P5SEL.4 | P5DIR.4 | P5DIR.4 | P5OUT.4 | DVSS | P5IN.4 | Unused | COM3 |

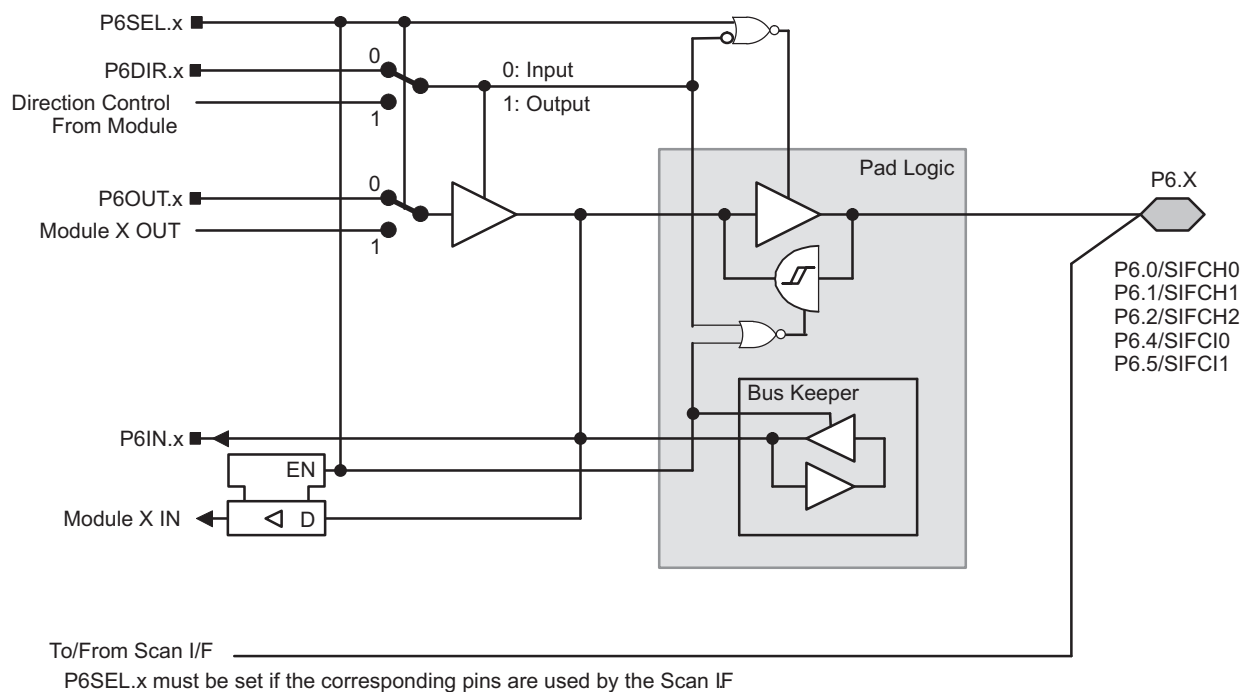
Port P5, P5.5 to P5.7, Input/Output With Schmitt Trigger



NOTE: $5 \leq x \leq 7$

| PnSEL.x | PnDIR.x | Direction Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN | Rxx |
|---------|---------|-------------------------------|---------|--------------|--------|-------------|-----|
| P5SEL.5 | P5DIR.5 | P5DIR.5 | P5OUT.5 | DVSS | P5IN.5 | Unused | R13 |
| P5SEL.6 | P5DIR.6 | P5DIR.6 | P5OUT.6 | DVSS | P5IN.6 | Unused | R23 |
| P5SEL.7 | P5DIR.7 | P5DIR.7 | P5OUT.7 | DVSS | P5IN.7 | Unused | R33 |

Port P6, P6.0, P6.1, P6.2, P6.4, P6.5, Input/Output With Schmitt Trigger



x: Bit Identifier = 0, 1, 2, 4, or 5

NOTE

Analog signals applied to digital gates can cause current flow from the positive to the negative terminal. The throughput current flows if the analog signal is in the range of transitions 0→1 or 1→0. The value of the throughput current depends on the driving capability of the gate. For MSP430, it is approximately 100 μ A.

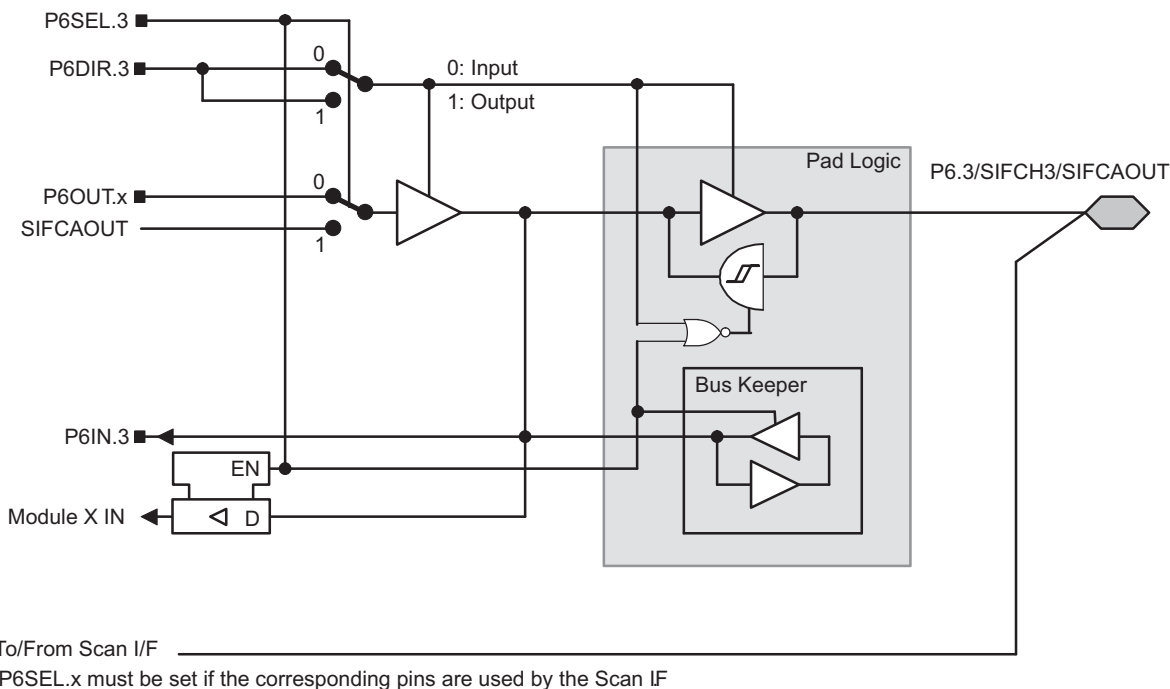
Use P6SEL.x=1 to prevent throughput current. P6SEL.x should be set, if an analog signal is applied to the pin.

| PnSEL.x | PnDIR.x | Dir. Control From Module | PnOUT.x | Module X OUT | PnIN.x | Module X IN |
|---------|---------|--------------------------|---------|--------------|--------|-------------|
| P6Sel.0 | P6DIR.0 | P6DIR.0 | P6OUT.0 | DVSS | P6IN.0 | unused |
| P6Sel.1 | P6DIR.1 | P6DIR.1 | P6OUT.1 | DVSS | P6IN.1 | unused |
| P6Sel.2 | P6DIR.2 | P6DIR.2 | P6OUT.2 | DVSS | P6IN.2 | unused |
| P6Sel.4 | P6DIR.4 | P6DIR.4 | P6OUT.4 | DVSS | P6IN.4 | unused |
| P6Sel.5 | P6DIR.5 | P6DIR.5 | P6OUT.5 | DVSS | P6IN.5 | unused |

NOTE

The signal at pins P6.x/SIFCHx and P6.x/SIFClx are shared by Port P6 and the Scan IF module. P6SEL.x must be set if the corresponding pins are used by the Scan IF.

Port P6, P6.3 Input/Output With Schmitt Trigger



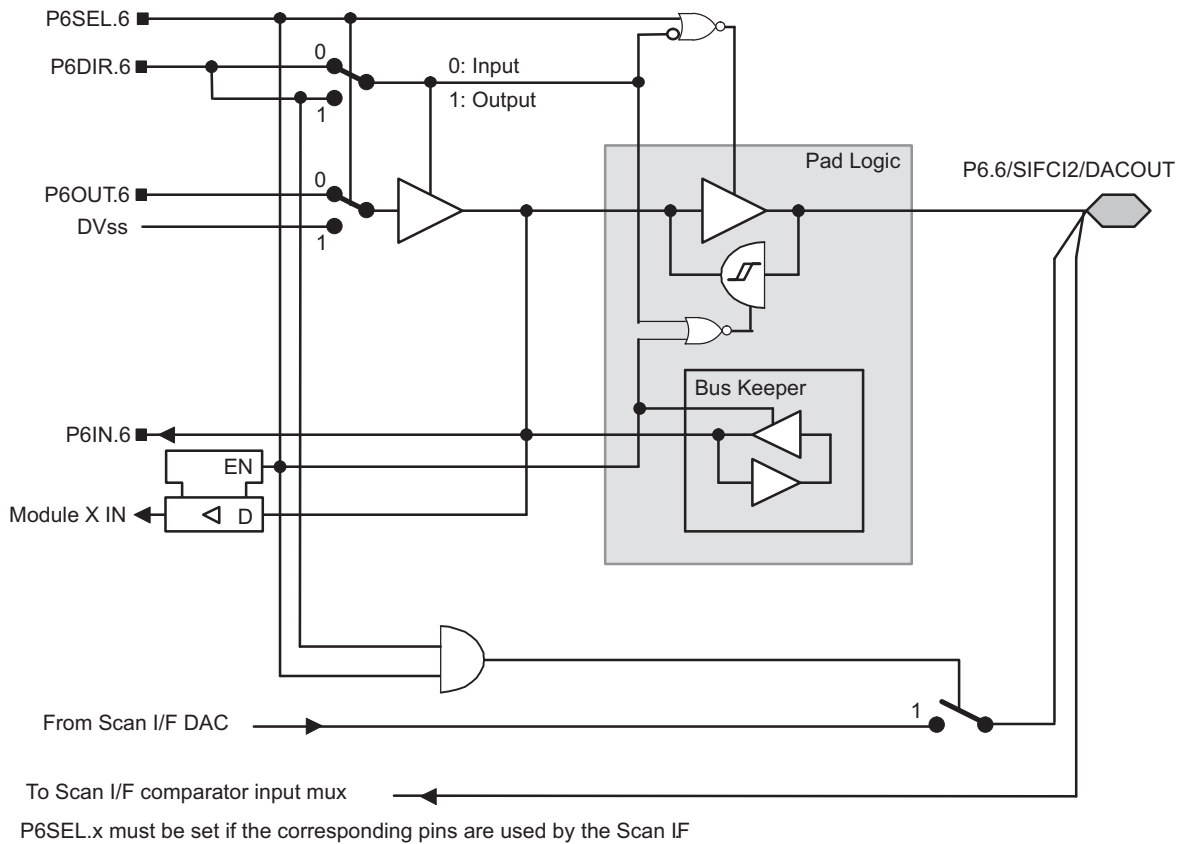
NOTE

Analog signals applied to digital gates can cause current flow from the positive to the negative terminal. The throughput current flows if the analog signal is in the range of transitions 0→1 or 1→0. The value of the throughput current depends on the driving capability of the gate. For MSP430, it is approximately 100 μ A.

Use P6SEL.x=1 to prevent throughput current. P6SEL.x should be set, if an analog signal is applied to the pin.

| P6SEL.3 | P6DIR.3 | Port Function |
|---------|---------|---|
| 0 | 0 | P6.3 Input |
| 0 | 1 | P6.3 Output |
| 1 | 0 | SIFCH3 (Scan IF channel 3 excitation output and comparator input) |
| 1 | 1 | SIFCAOUT (Comparator output) |

Port P6, P6.6 Input/Output With Schmitt Trigger



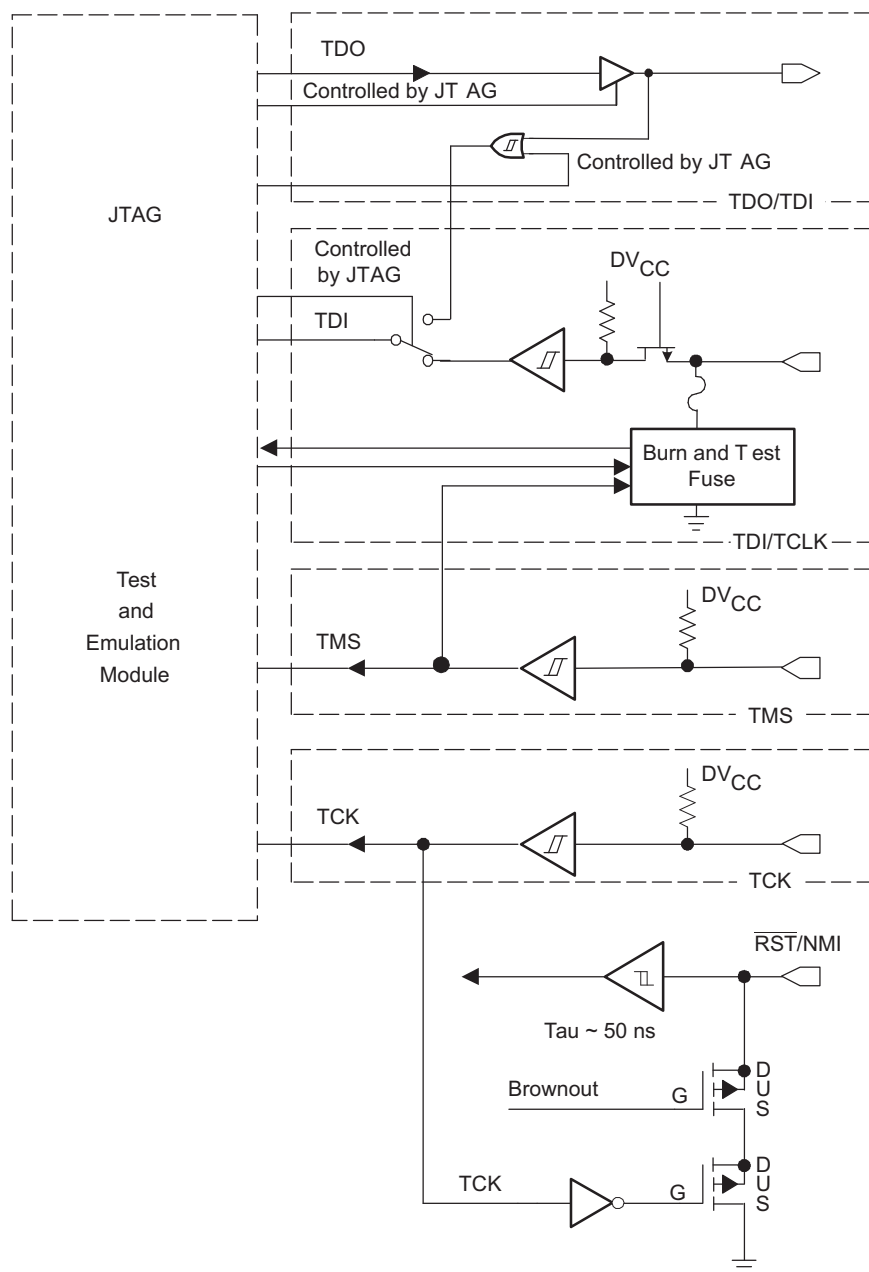
NOTE

Analog signals applied to digital gates can cause current flow from the positive to the negative terminal. The throughput current flows if the analog signal is in the range of transitions 0→1 or 1→0. The value of the throughput current depends on the driving capability of the gate. For MSP430, it is approximately 100 μ A.

Use P6SEL.x=1 to prevent throughput current. P6SEL.x should be set, if an analog signal is applied to the pin.

| P6SEL.6 | P6DIR.6 | Port Function |
|---------|---------|---|
| 0 | 0 | P6.6 Input |
| 0 | 1 | P6.6 Output |
| 1 | 0 | SIFCI2 (Scan IF channel 2 comparator input) |
| 1 | 1 | SIFDAOUT (Scan IF DAC output) |

JTAG Pins TMS, TCK, TDI/TCLK, TDO/TDI, Input/Output with Schmitt-Trigger or Output



JTAG Fuse Check Mode

MSP430 devices that have the fuse on the TDI/TCLK terminal have a fuse check mode that tests the continuity of the fuse the first time the JTAG port is accessed after a power-on reset (POR). When activated, a fuse check current (I_{TF}) of 1.8 mA at 3 V can flow from the TDI/TCLK pin to ground if the fuse is not burned. Care must be taken to avoid accidentally activating the fuse check mode and increasing overall system power consumption.

Activation of the fuse check mode occurs with the first negative edge on the TMS pin after power up or if the TMS is being held low during power up. The second positive edge on the TMS pin deactivates the fuse check mode. After deactivation, the fuse check mode remains inactive until another POR occurs. After each POR the fuse check mode has the potential to be activated.

The fuse check current only flows when the fuse check mode is active and the TMS pin is in a low state (see [Figure 21](#)). Therefore, the additional current flow can be prevented by holding the TMS pin high (default condition). The JTAG pins are terminated internally and therefore do not require external termination.

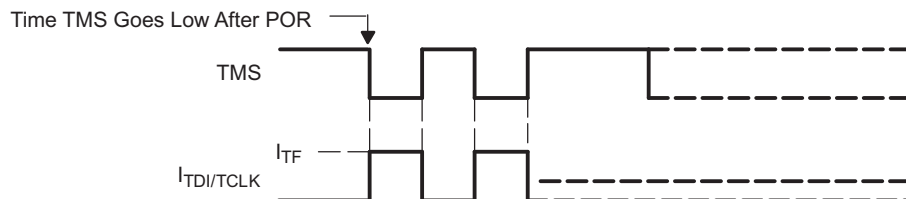


Figure 21. Fuse Check Mode Current

REVISION HISTORY

| REVISION | COMMENTS |
|----------|--|
| SLAS383 | Initial release |
| SLAS383A | <p>Clarified descriptions for AV_{CC} and AV_{SS} in Terminal Functions table (page 4)</p> <p>Clarified notes in Interrupt Vector Addresses (page 8)</p> <p>Removed V_{IL} and V_{IH} entries from Recommended Operating Conditions (page 18)</p> <p>Changed note 2 on Recommended Operating Conditions (page 18)</p> <p>Added to Wakeup LPM3 table (page 22)</p> <p>Removed TAx references in Comparator_A table (page 23)</p> <p>Clarified notes on Flash Memory table (page 36)</p> |
| SLAS383B | <p>Updated functional block diagram (page 3)</p> <p>Clarified test conditions in recommended operating conditions table (page 18)</p> <p>Clarified test conditions in electrical characteristics table (page 19)</p> <p>Added $I_{kg}(P_{x,x})$ for all ports in leakage current table (page 20)</p> <p>Clarified test conditions in DCO table (page 29)</p> <p>Changed t_{CPT} maximum value from 4 ms to 10 ms in Flash Memory table (page 36)</p> |
| SLAS383C | Updated max values for V_{IC} and V_{hys} in Scan IF, Comparator table (page 35) |
| SLAS383D | Added information about FW428 and FW429 |
| SLAS383E | <p>Recommended Operating Conditions, Added test conditions for typical values.</p> <p>Port P2, P2.0 to P2.7, Input/Output With Schmitt Trigger, At the top left of the image, changed LCDM.5, LCDM.6, and LCDM.7 to LCDPx.0, LCDPx.1, and LCDPx.2, respectively.</p> <p>Port P3, P3.0 to P3.7, Input/Output With Schmitt Trigger, At the top left of the image, changed LCDM.5, LCDM.6, and LCDM.7 to LCDPx.0, LCDPx.1, and LCDPx.2, respectively.</p> <p>Port P4, P4.0 to P4.7, Input/Output With Schmitt Trigger, At the top left of the image, changed LCDM.5, LCDM.6, and LCDM.7 to LCDPx.0, LCDPx.1, and LCDPx.2, respectively.</p> <p>Port P5, P5.0, P5.1, Input/Output With Schmitt Trigger, At the top left of the image, changed LCDM.5, LCDM.6, and LCDM.7 to LCDPx.0, LCDPx.1, and LCDPx.2, respectively.</p> |

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|----------------------------|-------------------------|----------------------|--------------|-------------------------|-------------------------|
| MSP430FW423IPM | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW423 | Samples |
| MSP430FW423IPMR | ACTIVE | LQFP | PM | 64 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW423 | Samples |
| MSP430FW425IPM | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW425 | Samples |
| MSP430FW425IPMR | ACTIVE | LQFP | PM | 64 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW425 | Samples |
| MSP430FW427IPM | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW427 REV # | Samples |
| MSP430FW427IPMR | ACTIVE | LQFP | PM | 64 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW427 REV # | Samples |
| MSP430FW428IPM | PREVIEW | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW428 | |
| MSP430FW428IPMR | ACTIVE | LQFP | PM | 64 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW428 | Samples |
| MSP430FW429IPM | ACTIVE | LQFP | PM | 64 | 160 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW429 | Samples |
| MSP430FW429IPMR | ACTIVE | LQFP | PM | 64 | 1000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR | | M430FW429 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| MSP430FW423IPMR | LQFP | PM | 64 | 1000 | 330.0 | 24.4 | 13.0 | 13.0 | 2.1 | 16.0 | 24.0 | Q2 |
| MSP430FW425IPMR | LQFP | PM | 64 | 1000 | 330.0 | 24.4 | 13.0 | 13.0 | 2.1 | 16.0 | 24.0 | Q2 |
| MSP430FW427IPMR | LQFP | PM | 64 | 1000 | 330.0 | 24.4 | 13.0 | 13.0 | 2.1 | 16.0 | 24.0 | Q2 |
| MSP430FW428IPMR | LQFP | PM | 64 | 1000 | 330.0 | 24.4 | 13.0 | 13.0 | 2.1 | 16.0 | 24.0 | Q2 |
| MSP430FW429IPMR | LQFP | PM | 64 | 1000 | 330.0 | 24.4 | 13.0 | 13.0 | 2.1 | 16.0 | 24.0 | Q2 |

TAPE AND REEL BOX DIMENSIONS

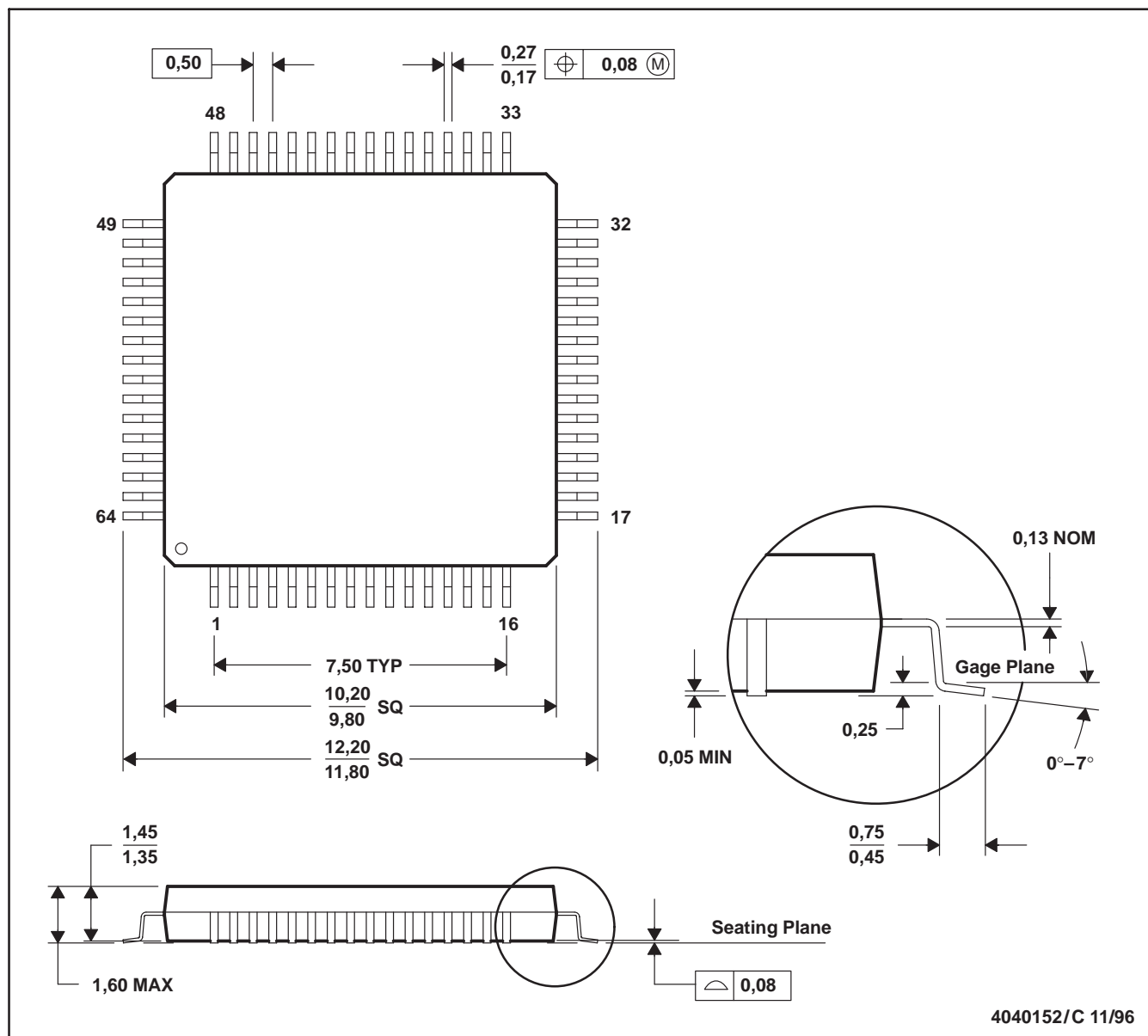


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| MSP430FW423IPMR | LQFP | PM | 64 | 1000 | 336.6 | 336.6 | 41.3 |
| MSP430FW425IPMR | LQFP | PM | 64 | 1000 | 336.6 | 336.6 | 41.3 |
| MSP430FW427IPMR | LQFP | PM | 64 | 1000 | 336.6 | 336.6 | 41.3 |
| MSP430FW428IPMR | LQFP | PM | 64 | 1000 | 336.6 | 336.6 | 41.3 |
| MSP430FW429IPMR | LQFP | PM | 64 | 1000 | 336.6 | 336.6 | 41.3 |

PM (S-PQFP-G64)

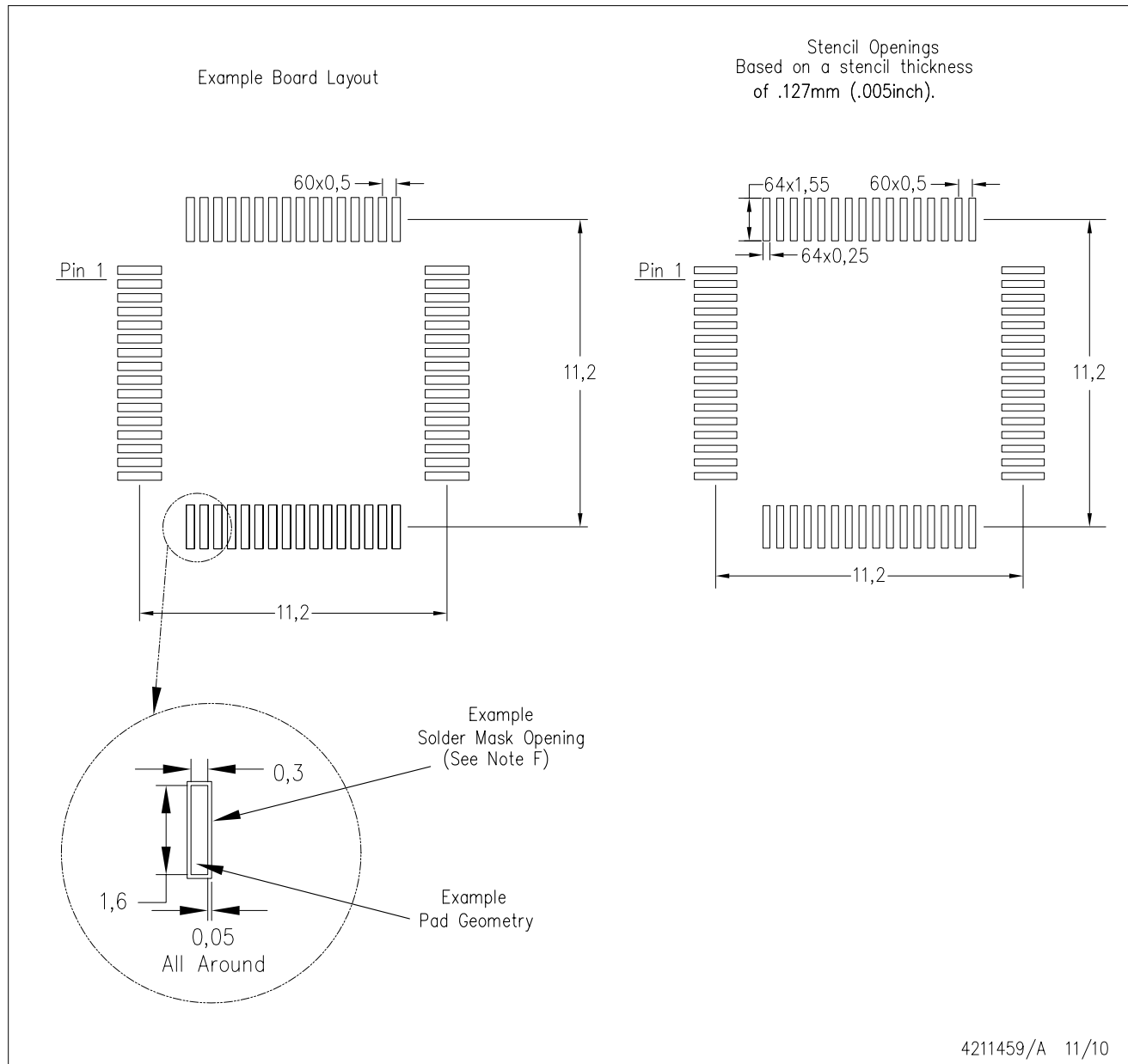
PLASTIC QUAD FLATPACK



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Falls within JEDEC MS-026
 - May also be thermally enhanced plastic with leads connected to the die pads.

PM (S-PQFP-G64)

PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - D. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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